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PART 27 MEASUREMENT REPORT

Applicant Name:
Samsung Electronics Co., Ltd.
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Yeongtong-gu, Suwon-si
Gyeonggi-do, 16677, Korea

Date of Testing:
12/13/2022 - 12/20/2022
Test Report Issue Date:
12/22/2022
Test Site/Location:
Element lab., Columbia, MD, USA
Test Report Serial No.:
1M2212080137-03-R1.A3L

FCC ID:	A3LSMS918JPN
APPLICANT:	Samsung Electronics Co., Ltd.

Application Type: Certification
Model(s): SC-52D, SCG20
EUT Type: Portable Handset
FCC Classification: PCS Licensed Transmitter Held to Ear (PCE)
FCC Rule Part: 27
Test Procedure(s): ANSI C63.26-2015, KDB 648474 D03 v01r04

This equipment has been shown to be capable of compliance with the applicable technical standards as indicated in the measurement report and was tested in accordance with the measurement procedures specified in §2.947. Test results reported herein relate only to the item(s) tested.

Note: This revised Test Report (S/N: 1M2212080137-03-R1.A3L) supersedes and replaces the previously issued test report on the same subject device for the same type of testing as indicated. Please discard or destroy the previously issued test report(s) and dispose of it accordingly.

I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.

RJ Ortanez
Executive Vice President



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FCC Part 27

Mode	Bandwidth	Modulation	Tx Frequency Range [MHz]	ERP		EIRP		Emission Designator
				Max. Power [W]	Max. Power [dBm]	Max. Power [W]	Max. Power [dBm]	
LTE Band 12	10 MHz	QPSK	704.0 - 711.0	0.064	18.04	0.104	20.19	9M00G7D
		16QAM	704.0 - 711.0	0.056	17.46	0.091	19.61	9M02W7D
	5 MHz	QPSK	701.5 - 713.5	0.066	18.17	0.108	20.32	4M51G7D
		16QAM	701.5 - 713.5	0.057	17.55	0.093	19.70	4M53W7D
	3 MHz	QPSK	700.5 - 714.5	0.062	17.92	0.102	20.07	2M73G7D
		16QAM	700.5 - 714.5	0.055	17.38	0.090	19.53	2M72W7D
1.4 MHz	QPSK	699.7 - 715.3	0.059	17.73	0.097	19.88	1M11G7D	
	16QAM	699.7 - 715.3	0.051	17.08	0.084	19.23	1M11W7D	
LTE Band 13	10 MHz	QPSK	782.0	0.131	21.17	0.215	23.32	9M03G7D
		16QAM	782.0	0.107	20.30	0.176	22.45	9M05W7D
	5 MHz	QPSK	779.5 - 784.5	0.131	21.17	0.215	23.32	4M55G7D
		16QAM	779.5 - 784.5	0.106	20.25	0.174	22.40	4M53W7D

Mode	Bandwidth	Modulation	Tx Frequency Range [MHz]	EIRP		Emission Designator
				Max. Power [W]	Max. Power [dBm]	
LTE Band 66/4	20 MHz	QPSK	1720.0 - 1770.0	0.214	23.31	18M0G7D
		16QAM	1720.0 - 1770.0	0.183	22.62	18M0W7D
	15 MHz	QPSK	1717.5 - 1772.5	0.218	23.39	13M5G7D
		16QAM	1717.5 - 1772.5	0.188	22.73	13M5W7D
	10 MHz	QPSK	1715.0 - 1775.0	0.220	23.43	9M06G7D
		16QAM	1715.0 - 1775.0	0.203	23.08	9M03W7D
	5 MHz	QPSK	1712.5 - 1777.5	0.226	23.54	4M53G7D
		16QAM	1712.5 - 1777.5	0.197	22.94	4M52W7D
	3 MHz	QPSK	1711.5 - 1778.5	0.223	23.48	2M73G7D
		16QAM	1711.5 - 1778.5	0.191	22.80	2M71W7D
	1.4 MHz	QPSK	1710.7 - 1779.3	0.205	23.12	1M10G7D
		16QAM	1710.7 - 1779.3	0.177	22.48	1M11W7D

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1.0 INTRODUCTION

1.1 Scope

Measurement and determination of electromagnetic emissions (EMC) of radio frequency devices including intentional and/or unintentional radiators for compliance with the technical rules and regulations of the Federal Communications Commission and the Innovation, Science and Economic Development Canada.

1.2 Element Test Location

These measurement tests were conducted at the Element laboratory located at 7185 Oakland Mills Road, Columbia, MD 21046. The measurement facility is compliant with the test site requirements specified in ANSI C63.4-2014.

1.3 Test Facility / Accreditations

Measurements were performed at Element lab located in Columbia, MD 21046, U.S.A.

- Element Washington DC LLC is an ISO 17025-2017 accredited test facility under the American Association for Laboratory Accreditation (A2LA) with Certificate number 2041.01 for Specific Absorption Rate (SAR), Hearing Aid Compatibility (HAC) testing, where applicable, and Electromagnetic Compatibility (EMC) testing for FCC and Innovation, Science, and Economic Development Canada rules.
- Element Washington DC LLC TCB is a Telecommunication Certification Body (TCB) accredited to ISO/IEC 17065-2012 by A2LA (Certificate number 2041.03) in all scopes of FCC Rules and ISED Standards (RSS).
- Element Washington DC LLC facility is a registered (2451B) test laboratory with the site description on file with ISED.
- Element Washington DC LLC is a Recognized U.S. Certification Assessment Body (CAB # US0110) for ISED Canada as designated by NIST under the U.S. and Canada Mutual Recognition Agreement.

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2.0 PRODUCT INFORMATION

2.1 Equipment Description

The Equipment Under Test (EUT) is the **Samsung Portable Handset FCC ID: A3LSMS918JPN**. The test data contained in this report pertains only to the emissions due to the EUT's licensed transmitters that operate under the provisions of Part 27.

Test Device Serial No.: 0946M, 0984M

2.2 Device Capabilities

This device contains the following capabilities:

850/1900 GSM/GPRS/EDGE, 850 WCDMA/HSPA, Multi-band LTE, Multi-band 5G NR (FR1), 802.11b/g/n/ax WLAN, 802.11a/n/ac/ax UNII (5GHz and 6GHz), Bluetooth (1x, EDR, LE), NFC, UWB, Wireless Power Transfer

This device uses a tuner circuit that dynamically updates the antenna impedance parameters to optimize antenna performance for certain bands and modes of operation. The tuner for this device was set to simulate a "free space" condition where the transmit antenna is matched to the medium into which it is transmitting and, thus, the power is at its maximum level.

2.3 Test Configuration

The EUT was tested per the guidance of ANSI C63.26-2015. See Section 7.0 of this test report for a description of the radiated and antenna port conducted emissions tests.

This device supports wireless charging capability and, thus, is subject to the test requirements of KDB 648474 D03 v01r04. Additional radiated spurious emission measurements were performed with the EUT lying flat on an authorized wireless charging pad (WCP) Model: EP-N5100 while operating under normal conditions in a simulated call or data transmission configuration. The worst case radiated emissions data is shown in this report.

2.4 Software and Firmware

Testing was performed on device(s) using software/firmware version S918USQU0AVJH installed on the EUT.

2.5 EMI Suppression Device(s)/Modifications

No EMI suppression device(s) were added and no modifications were made during testing.

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3.0 DESCRIPTION OF TESTS

3.1 Evaluation Procedure

The measurement procedures described in the “American National Standard for Compliance Testing of Transmitters Used in Licensed Radio Services” (ANSI C63.26-2015) were used in the measurement of the EUT.

Deviation from Measurement Procedure.....None

3.2 Radiated Power and Radiated Spurious Emissions

The radiated test facilities consisted of an indoor 3 meter semi-anechoic chamber used for final measurements and exploratory measurements, when necessary. The measurement area is contained within the semi-anechoic chamber which is shielded from any ambient interference. The test site inside the chamber is a 6m x 5.2m elliptical, obstruction-free area in accordance with Figure 5.7 of Clause 5 in ANSI C63.4-2014. Absorbers are arranged on the floor between the turn table and the antenna mast in such a way so as to maximize the reduction of reflections for measurements above 1GHz. For measurements below 1GHz, the absorbers are removed. A raised turntable is used for radiated measurement. The turn table is a continuously rotatable, remote-controlled, metallic turntable and 2 meters (6.56 ft.) in diameter. The turn table is flush with the raised floor of the chamber in order to maintain its function as a ground plane. An 80cm tall test table made of Styrodur is placed on top of the turn table. A Styrodur pedestal is placed on top of the test table to bring the total table height to 1.5m.

The equipment under test was transmitting while connected to its integral antenna and is placed on a turntable 3 meters from the receive antenna. The receive antenna height is adjusted between 1 and 4 meter height, the turntable is rotated through 360 degrees, and the EUT is manipulated through all orthogonal planes representative of its typical use to achieve the highest reading on the receive spectrum analyzer.

For radiated power measurements, substitution method is used per the guidance of ANSI C63.26-2015. For emissions below 1GHz, a half-wave dipole is substituted in place of the EUT. For emissions above 1GHz, a horn antenna is substituted in place of the EUT. The substitute antenna is driven by a signal generator with the level of the signal generator being adjusted to obtain the same receive spectrum analyzer level previously recorded from the spurious emission from the EUT. The power of the emission is calculated using the following formula:

$$P_d [dBm] = P_g [dBm] - \text{cable loss} [dB] + \text{antenna gain} [dBd/dBi];$$

where P_d is the dipole equivalent power, P_g is the generator output into the substitution antenna, and the antenna gain is the gain of the substitute antenna used relative to either a half-wave dipole (dBd) or an isotropic source (dBi). The substitute level is equal to $P_g [dBm] - \text{cable loss} [dB]$.

For radiated spurious emissions measurements, the field strength conversion method is used per the formulas in Section 5.2.7 of ANSI C63.26-2015. Field Strength (EIRP) is calculated using the following formulas:

$$E_{[dB\mu V/m]} = \text{Measured amplitude level}_{[dBm]} + 107 + \text{Cable Loss}_{[dB]} + \text{Antenna Factor}_{[dB/m]}$$

And

$$\text{EIRP}_{[dBm]} = E_{[dB\mu V/m]} + 20\log D - 104.8; \text{ where } D \text{ is the measurement distance in meters.}$$

All radiated measurements are performed in a chamber that meets the site requirements per ANSI C63.4-2014. Additionally, radiated emissions below 30MHz are also validated on an Open Area Test Site to assert correlation with the chamber measurements per the requirements of KDB 414788 D01 v01r01.

Radiated power and radiated spurious emission levels are investigated with the receive antenna horizontally and vertically polarized per ANSI C63.26-2015.

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4.0 MEASUREMENT UNCERTAINTY

The measurement uncertainties shown below were calculated in accordance with the requirements of ANSI C63.4-2014. All measurement uncertainty values are shown with a coverage factor of $k = 2$ to indicate a 95% level of confidence. The measurement uncertainty shown below meets or exceeds the U_{CISPR} measurement uncertainty values specified in CISPR 16-4-2 and, thus, can be compared directly to specified limits to determine compliance.

Contribution	Expanded Uncertainty (\pm dB)
Conducted Bench Top Measurements	1.13
Radiated Disturbance (<1GHz)	4.98
Radiated Disturbance (>1GHz)	5.07
Radiated Disturbance (>18GHz)	5.09

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5.0 TEST EQUIPMENT CALIBRATION DATA

Test Equipment Calibration is traceable to the National Institute of Standards and Technology (NIST). Measurements antennas used during testing were calibrated in accordance to the requirements of ANSI C63.5-2017.

Manufacturer	Model	Description	Cal Date	Cal Interval	Cal Due	Serial Number
-	AP2	EMC Cable and Switch System	8/11/2022	Annual	8/11/2023	AP2
-	AP1	EMC Cable and Switch System	8/15/2022	Annual	8/15/2023	AP1
-	ETS	EMC Cable and Switch System	8/11/2022	Annual	8/11/2023	ETS
-	LTx1	Licensed Transmitter Cable Set	7/29/2022	Annual	7/29/2023	LTx1
-	LTx2	Licensed Transmitter Cable Set	8/15/2022	Annual	8/15/2023	LTx2
-	LTx3	Licensed Transmitter Cable Set	8/15/2022	Annual	8/15/2023	LTx3
-	LTx4	Licensed Transmitter Cable Set	7/29/2022	Annual	7/29/2023	LTx4
-	LTx5	Licensed Transmitter Cable Set	7/29/2022	Annual	7/29/2023	LTx5
Agilent	E5515C	Wireless Communications Test Set		N/A		GB45360985
Agilent	E5515C	Wireless Communications Test Set		N/A		GB46310798
Anritsu	MT8820C	Radio Communication Analyzer		N/A		6201300731
Anritsu	MT8821C	Radio Communication Analyzer		N/A		6201381794
Anritsu	MT8821C	Radio Communication Analyzer		N/A		6200901190
Anritsu	MT8821C	Radio Communication Analyzer		N/A		6201525694
Com-Power	AL-130R	Active Loop Antenna	1/19/2022	Biennial	1/19/2024	121085
Emco	3115	Horn Antenna (1-18GHz)	8/8/2022	Biennial	8/8/2024	9704-5182
Espec	ESX-2CA	Environmental Chamber	5/25/2022	Biennial	5/25/2024	17620
ETS Lindgren	3117	1-18 GHz DRG Horn (Medium)	4/20/2021	Biennial	4/20/2023	00125518
ETS Lindgren	3164-10	Quad Ridge Horn 400MHz - 10000MHz	5/10/2021	Biennial	5/10/2023	00166283
ETS Lindgren	3816/2NM	LISN	8/11/2022	Biennial	8/11/2024	00114451
Keysight Technologies	N9020A	MXA Signal Analyzer	3/15/2022	Annual	3/15/2023	MY54500644
Keysight Technologies	N9030A	PXA Signal Analyzer (44GHz)	8/18/2022	Annual	8/18/2023	MY49430494
Keysight Technologies	N9030A	PXA Signal Analyzer (44GHz)	2/14/2022	Annual	2/14/2023	MY52350166
Mini-Circuits	SSG-4000HP	Synthesized Signal Generator		N/A		11208010032
Mini-Circuits	SSG-4000HP	Synthesized Signal Generator		N/A		11403100002
Rohde & Schwarz	CMW500	Radio Communication Tester		N/A		100976
Rohde & Schwarz	CMW500	Radio Communication Tester		N/A		112347
Rohde & Schwarz	ESU26	EMI Test Receiver (26.5GHz)	8/29/2022	Annual	8/29/2023	100342
Rohde & Schwarz	ESU40	EMI Test Receiver (40GHz)	8/25/2022	Annual	8/25/2023	100348
Rohde & Schwarz	ESW44	EMI Test Receiver 2Hz to 44 GHz	3/28/2022	Annual	3/28/2023	101716
Rohde & Schwarz	FSW26	2Hz-26.5GHz Signal and Spectrum Analyzer	4/14/2022	Annual	4/14/2023	103187
Sunol	JB6	LB6 Antenna	11/13/2020	Biennial	11/13/2022	A082816

Table 5-1. Test Equipment

Notes:

1. For equipment listed above that has a calibration date or calibration due date that falls within the test date range, care was taken to ensure that this equipment was used after the calibration date and before the calibration due date.
2. Equipment with a calibration date of "N/A" shown in this list was not used to make direct calibrated measurements.

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6.0 SAMPLE CALCULATIONS

Emission Designator

QPSK Modulation

Emission Designator = 8M62G7D

LTE BW = 8.62 MHz

G = Phase Modulation

7 = Quantized/Digital Info

D = Data transmission, telemetry, telecommand

QAM Modulation

Emission Designator = 8M45W7D

LTE BW = 8.45 MHz

W = Amplitude/Angle Modulated

7 = Quantized/Digital Info

D = Data transmission, telemetry, telecommand

Spurious Radiated Emission – LTE Band

Example: Middle Channel LTE Mode 2nd Harmonic (1564 MHz)

The average spectrum analyzer reading at 3 meters with the EUT on the turntable was -81.0 dBm. The gain of the substituted antenna is 8.1 dBi. The signal generator connected to the substituted antenna terminals is adjusted to produce a reading of -81.0 dBm on the spectrum analyzer. The loss of the cable between the signal generator and the terminals of the substituted antenna is 2.0 dB at 1564 MHz. So 6.1 dB is added to the signal generator reading of -30.9 dBm yielding -24.80 dBm. The fundamental EIRP was 25.501 dBm so this harmonic was 25.501 dBm $- (-24.80) = 50.3$ dBc.

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7.0 TEST RESULTS

7.1 Summary

Company Name: Samsung Electronics Co., Ltd.
 FCC ID: A3LSMS918JPN
 FCC Classification: PCS Licensed Transmitter Held to Ear (PCE)
 Mode(s): LTE

Test Condition	Test Description	FCC Part Section(s)	Test Limit	Test Result	Reference
CONDUCTED	Transmitter Conducted Output Power*	2.1046(a), 2.1046(c)	N/A	PASS	Section 7.2
	Occupied Bandwidth	2.1049(h)	N/A	PASS	Section 7.3
	Conducted Band Edge / Spurious Emissions (LTE Band 13)	2.1051, 27.53(c), 27.53(f)	Undesirable emissions must meet the limits detailed in sections 27.53(c) and 27.53(f)	PASS	Sections 7.4, 7.5
	Conducted Band Edge / Spurious Emissions (LTE Band 12)	2.1051, 27.53(g)	$\geq 43 + 10 \log (P[\text{Watts}])$ dB of attenuation below transmitter power	PASS	Sections 7.4, 7.5
	Conducted Band Edge / Spurious Emissions (LTE Band 4, 66)	2.1051, 27.53(h)	$\geq 43 + 10 \log (P[\text{Watts}])$ dB of attenuation below transmitter power	PASS	Sections 7.4, 7.5
	Peak-to-Average Ratio (LTE Band 4, 66)	27.50(d)(5)	≤ 13 dB	PASS	Section 7.6
	Frequency Stability	2.1055, 27.54	Fundamental emissions stay within authorized frequency block	PASS	Section 7.9
RADIATED	Effective Radiated Power (LTE Band 13)	27.50(b)(10)	≤ 3 Watts max. ERP	PASS	Section 7.7
	Effective Radiated Power (LTE Band 12)	27.50(c)(10)	≤ 3 Watts max. ERP	PASS	Section 7.7
	Equivalent Isotropic Radiated Power (LTE Band 4, 66)	27.50(d)(4)	≤ 1 Watt max. EIRP	PASS	Section 7.7
	Radiated Spurious Emissions (LTE Band 13)	2.1053, 27.53(c), 27.53(f)	Undesirable emissions must meet the limits detailed in sections 27.53(c) and 27.53(f)	PASS	Section 7.8
	Radiated Spurious Emissions (LTE Band 12)	2.1053, 27.53(g)	$\geq 43 + 10 \log (P[\text{Watts}])$ dB of attenuation below transmitter power	PASS	Section 7.8
	Radiated Spurious Emissions (LTE Band 4, 66)	2.1053, 27.53(h)(1)	$\geq 43 + 10 \log (P[\text{Watts}])$ dB of attenuation below transmitter power	PASS	Section 7.8

* The only transmitter output conducted powers included in this report are those where the Pmax value, per the tune-up document, is higher than any of the DSI power levels. For the remaining conducted power measurements, see the **RF Exposure Report**.

Table 7-1. Summary of Test Results

Notes:

- 1) All modes of operation and data rates were investigated. The test results shown in the following sections represent the worst case emissions.
- 2) The analyzer plots shown in Section 7.0 were taken with a correction table loaded into the analyzer. The correction table was used to account for the losses of the cables, directional couplers, and attenuators used as part of the system to maintain a link between the call box and the EUT at all frequencies of interest.
- 3) All antenna port conducted emissions testing was performed on a test bench with the antenna port of the EUT connected to the spectrum analyzer through calibrated cables, attenuators, and couplers.
- 4) For conducted spurious emissions, automated test software was used to measure emissions and capture the corresponding plots necessary to show compliance. The measurement software utilized is EMC Software Tool v1.0.

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7.2 Conducted Output Power Data

Test Overview

All emissions are measured with a spectrum analyzer connected to the antenna terminal of the EUT while the EUT is operating at its maximum duty cycle, at maximum power, and at the appropriate frequencies. All data rates were investigated to determine the worst-case configuration. All modes of operation were investigated and the worst-case configuration results are reported in this section.

Test Procedure Used

ANSI C63.26-2015 – Section 5.2

Test Settings

1. Detector = RMS
2. Trace mode = trace average for continuous emissions, max hold for pulse emissions
3. Sweep time = auto couple
4. The trace was allowed to stabilize
5. Please see test notes below for RBW and VBW settings

Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.

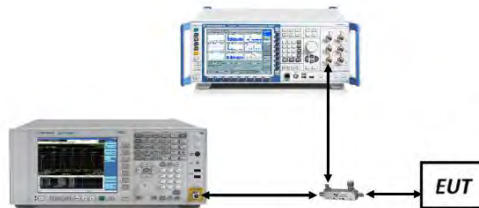


Figure 7-1. Test Instrument & Measurement Setup

Test Notes

1. Conducted power measurements were evaluated using various combinations of RB size, RB offset, modulation, and channel bandwidth. Channel bandwidth data is shown in the tables below based only on the channel bandwidths that were supported in this device.
2. All other conducted power measurements are contained in the RF exposure report for this filing.

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Bandwidth	Modulation	Channel	Frequency [MHz]	RB Size/Offset	Conducted Power [dBm]
20 MHz	QPSK	132072	1720.0	1 / 50	23.78
		132322	1745.0	1 / 50	23.74
		132572	1770.0	1 / 50	23.57
	16-QAM	132322	1745.0	1 / 50	22.88
15 MHz	QPSK	132047	1717.5	1 / 74	23.82
		132322	1745.0	1 / 0	23.82
		132597	1772.5	1 / 74	23.73
	16-QAM	132597	1772.5	1 / 37	23.07
10 MHz	QPSK	132022	1715.0	1 / 49	23.90
		132322	1745.0	1 / 0	23.86
		132622	1775.0	1 / 49	23.76
	16-QAM	132322	1745.0	1 / 0	23.34
5 MHz	QPSK	131997	1712.5	1 / 0	23.81
		132322	1745.0	1 / 12	23.90
		132647	1777.5	1 / 24	23.90
	16-QAM	132322	1745.0	1 / 12	23.20
3 MHz	QPSK	131987	1711.5	1 / 0	23.86
		132322	1745.0	1 / 0	23.72
		132657	1778.5	1 / 14	23.84
	16-QAM	132657	1778.5	1 / 7	23.14
1.4 MHz	QPSK	131979	1710.7	1 / 3	23.38
		132322	1745.0	1 / 3	23.47
		132665	1779.3	1 / 5	23.47
	16-QAM	132322	1745.0	1 / 3	22.74

Table 7-2. Conducted Powers (LTE Band 66/4)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1M2212080137-03-R1.A3L	Test Dates: 12/13/2022 - 12/20/2022	EUT Type: Portable Handset	Page 12 of 90

7.3 Occupied Bandwidth

Test Overview

The occupied bandwidth, that is the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers radiated are each equal to 0.5 percent of the total mean power radiated by a given emission shall be measured. All modes of operation were investigated and the worst-case configuration results are reported in this section.

Test Procedure Used

ANSI C63.26-2015 – Section 5.4.4

Test Settings

1. The signal analyzer's automatic bandwidth measurement capability was used to perform the 99% occupied bandwidth and the 26dB bandwidth. The bandwidth measurement was not influenced by any intermediate power nulls in the fundamental emission.
2. RBW = 1 – 5% of the expected OBW
3. VBW $\geq 3 \times$ RBW
4. Detector = Peak
5. Trace mode = max hold
6. Sweep = auto couple
7. The trace was allowed to stabilize
8. If necessary, steps 2 – 7 were repeated after changing the RBW such that it would be within 1 – 5% of the 99% occupied bandwidth observed in Step 7

Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.

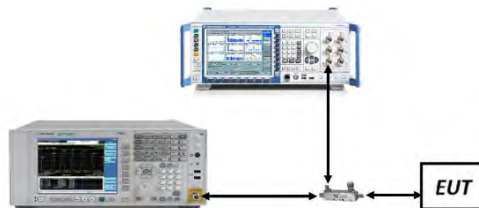


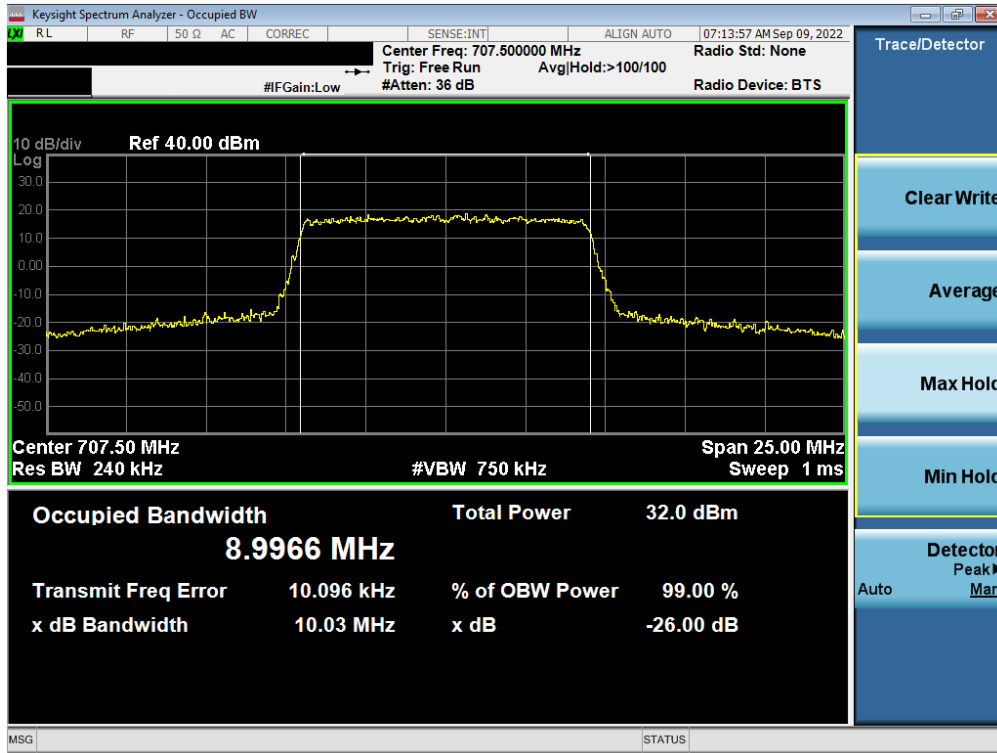
Figure 7-2. Test Instrument & Measurement Setup

Test Notes

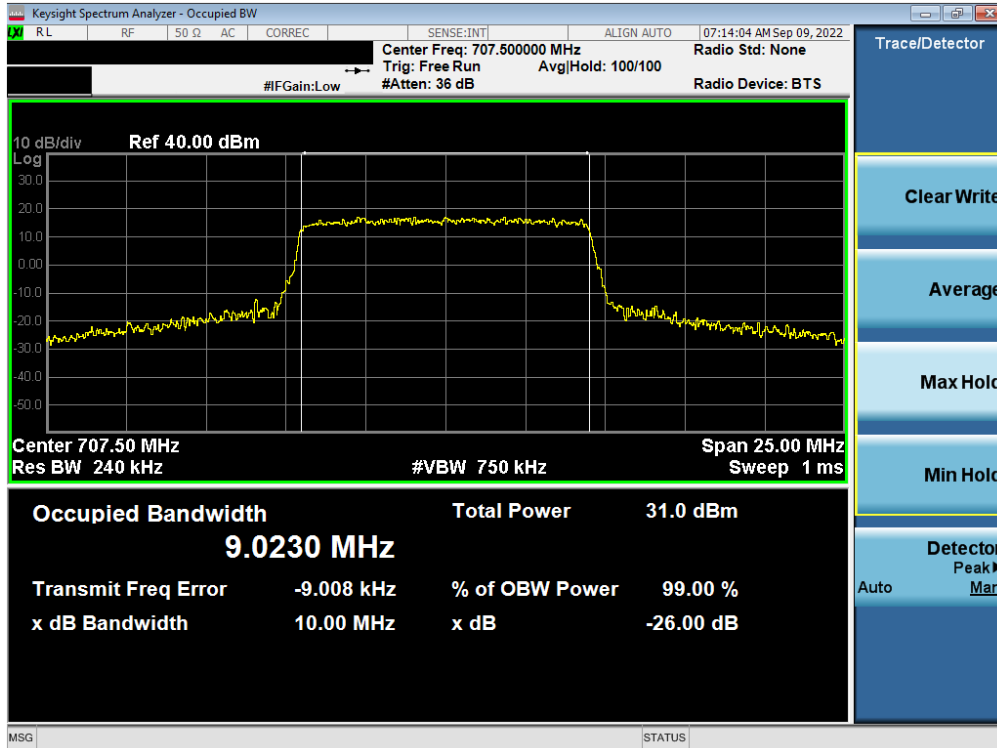
None.

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1M2212080137-03-R1.A3L	Test Dates: 12/13/2022 - 12/20/2022	EUT Type: Portable Handset	Page 13 of 90

LTE Band 12

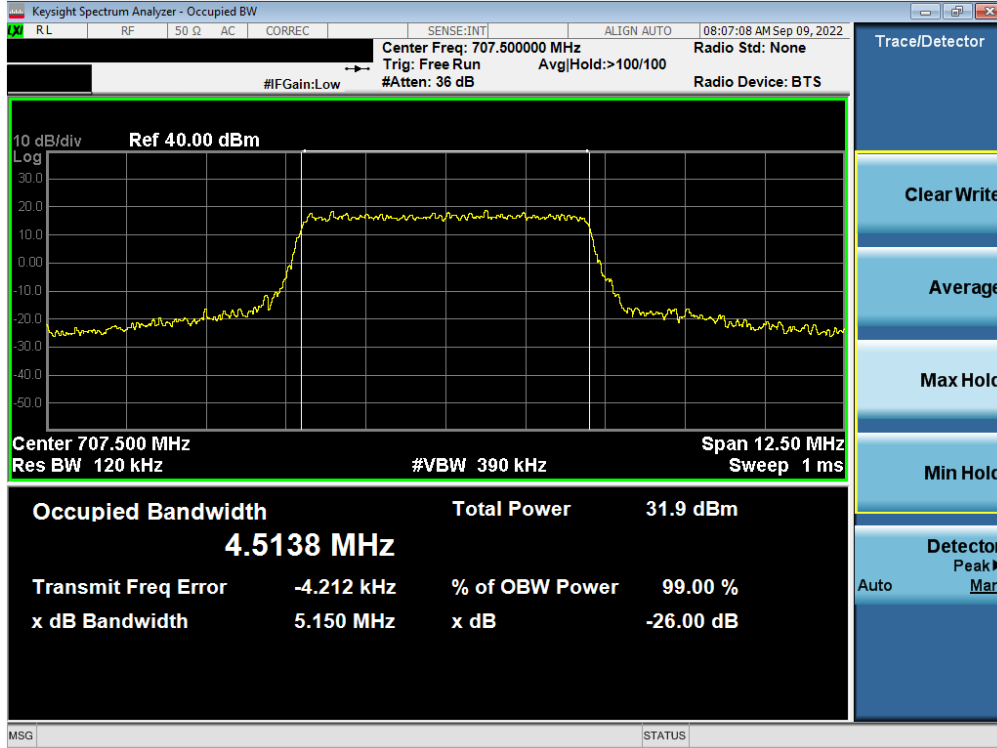


Plot 7-1. Occupied Bandwidth Plot (LTE Band 12 - 10MHz QPSK - Full RB)

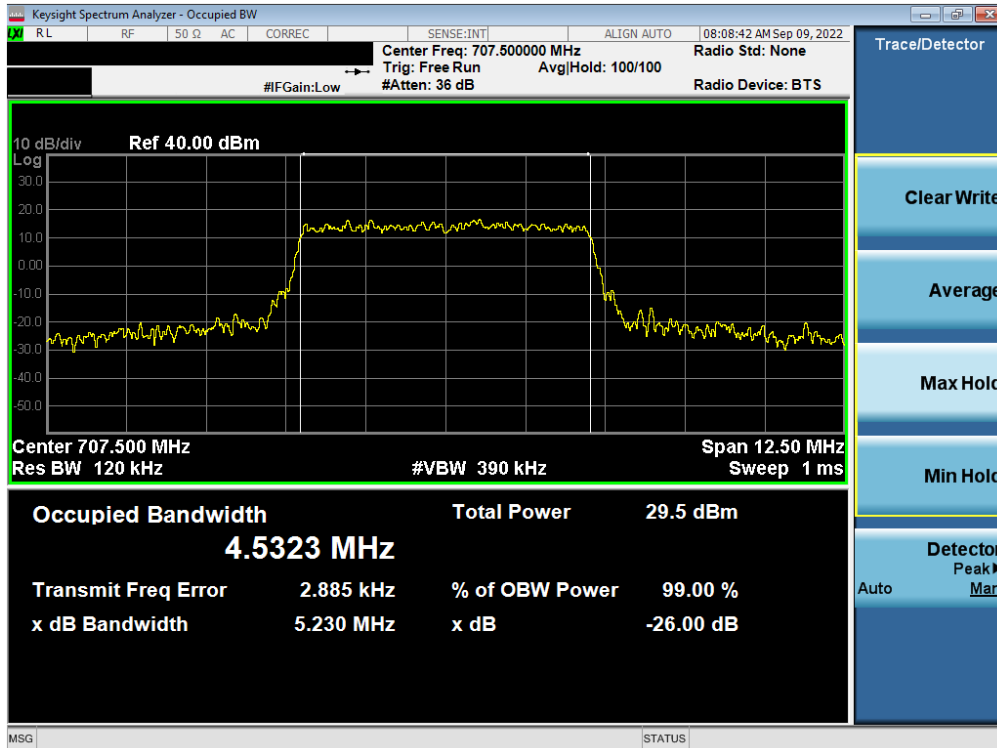


Plot 7-2. Occupied Bandwidth Plot (LTE Band 12 - 10MHz 16-QAM - Full RB)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1M2212080137-03-R1.A3L	Test Dates: 12/13/2022 - 12/20/2022	EUT Type: Portable Handset	Page 14 of 90

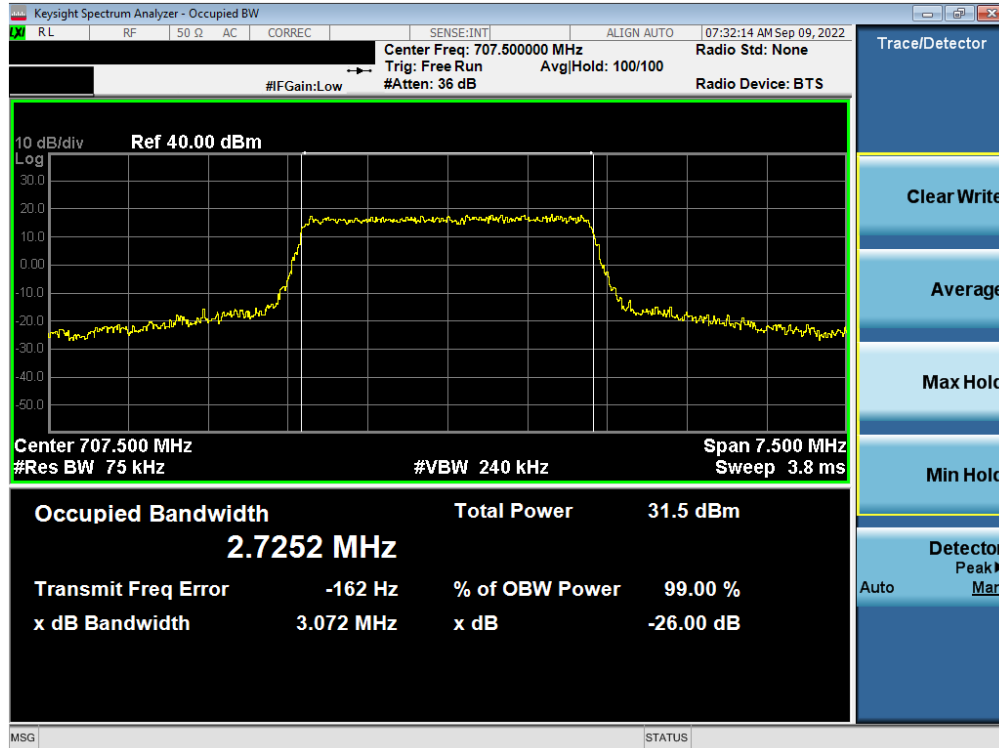


Plot 7-3. Occupied Bandwidth Plot (LTE Band 12 - 5MHz QPSK - Full RB)

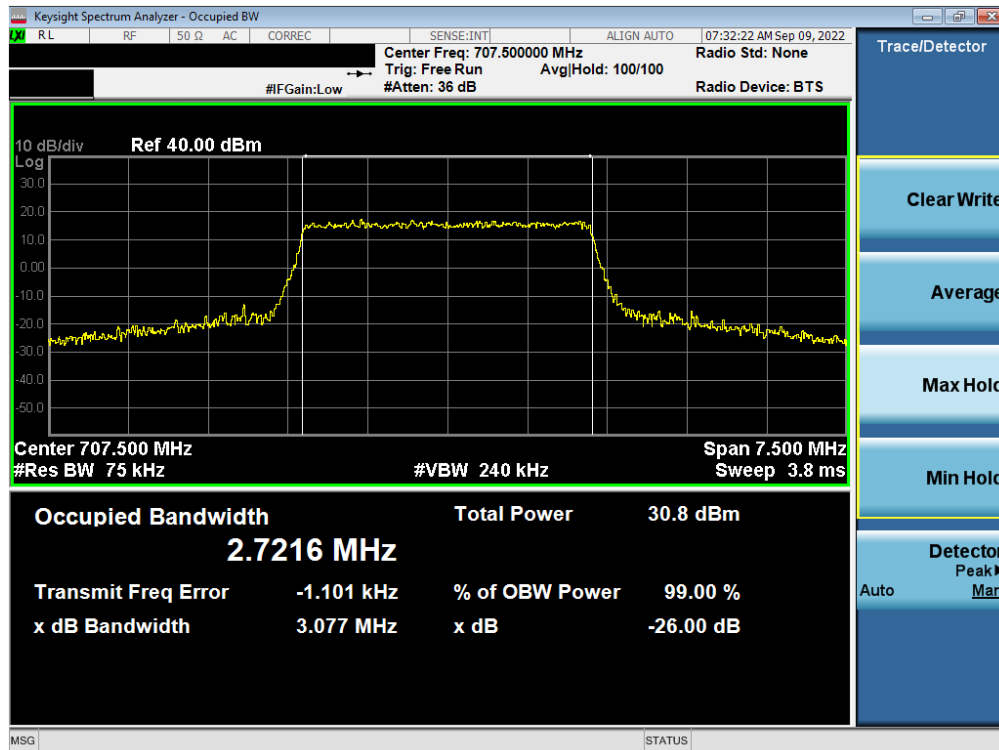


Plot 7-4. Occupied Bandwidth Plot (LTE Band 12 - 5MHz 16-QAM - Full RB)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1M2212080137-03-R1.A3L	Test Dates: 12/13/2022 - 12/20/2022	EUT Type: Portable Handset	Page 15 of 90

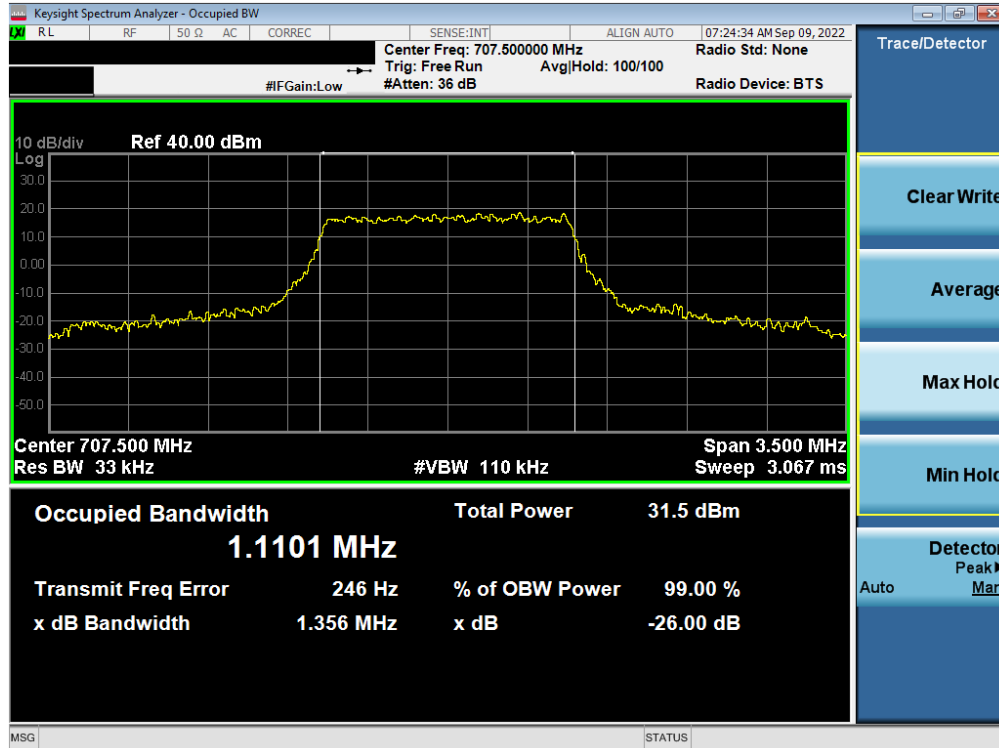


Plot 7-5. Occupied Bandwidth Plot (LTE Band 12 - 3MHz QPSK - Full RB)

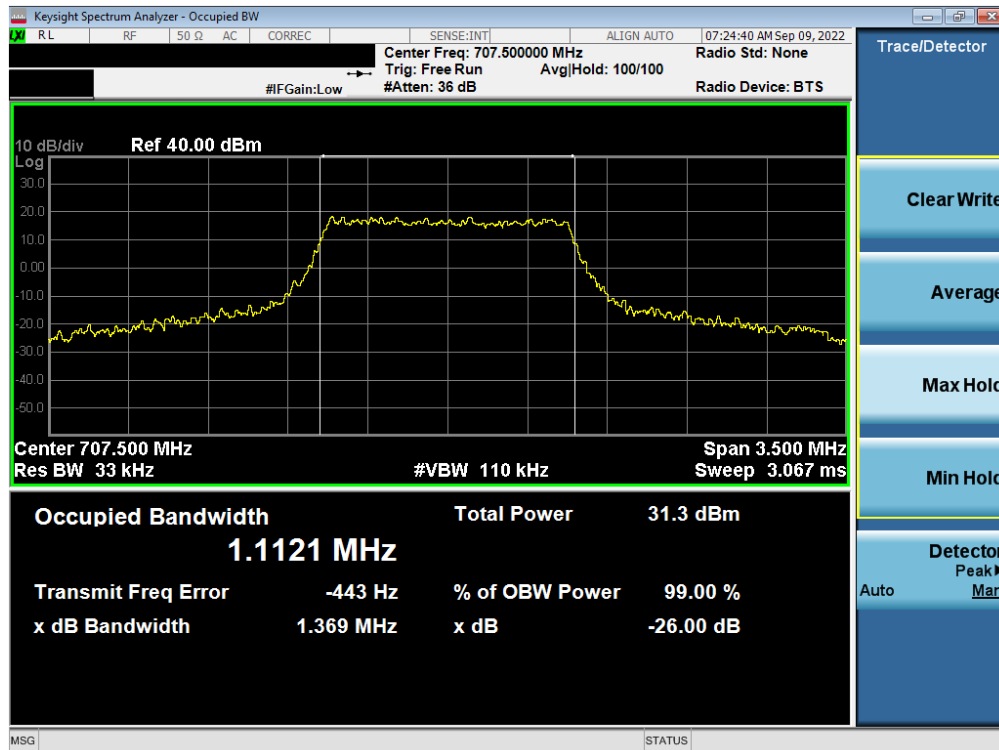


Plot 7-6. Occupied Bandwidth Plot (LTE Band 12 - 3MHz 16-QAM - Full RB)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1M2212080137-03-R1.A3L	Test Dates: 12/13/2022 - 12/20/2022	EUT Type: Portable Handset	Page 16 of 90



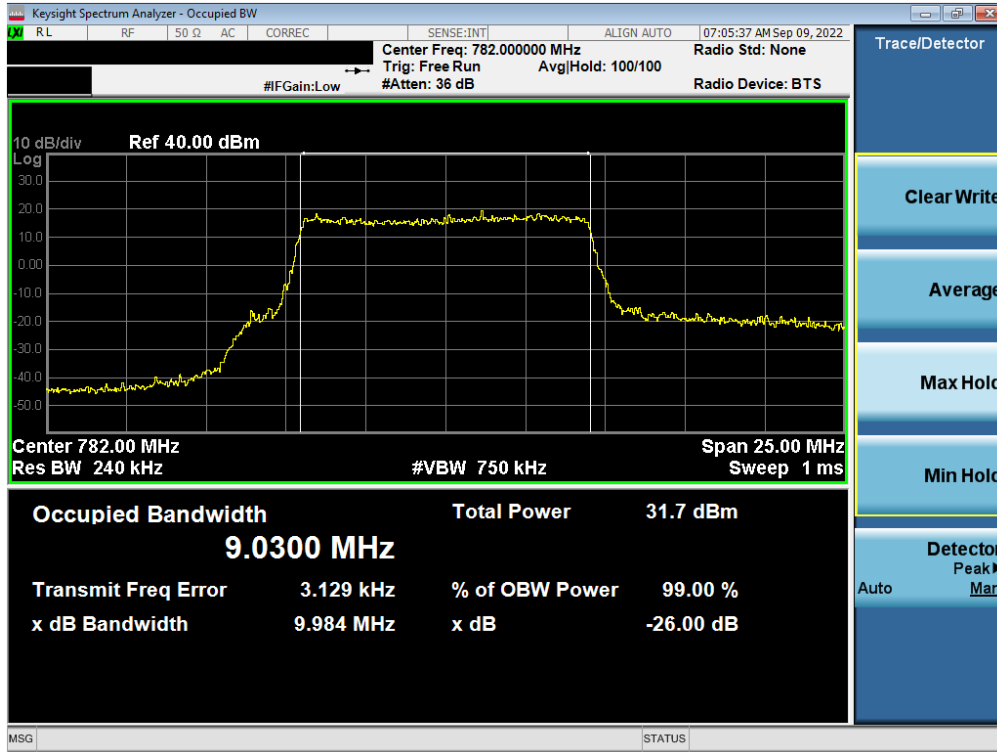
Plot 7-7. Occupied Bandwidth Plot (LTE Band 12 – 1.4MHz QPSK - Full RB)



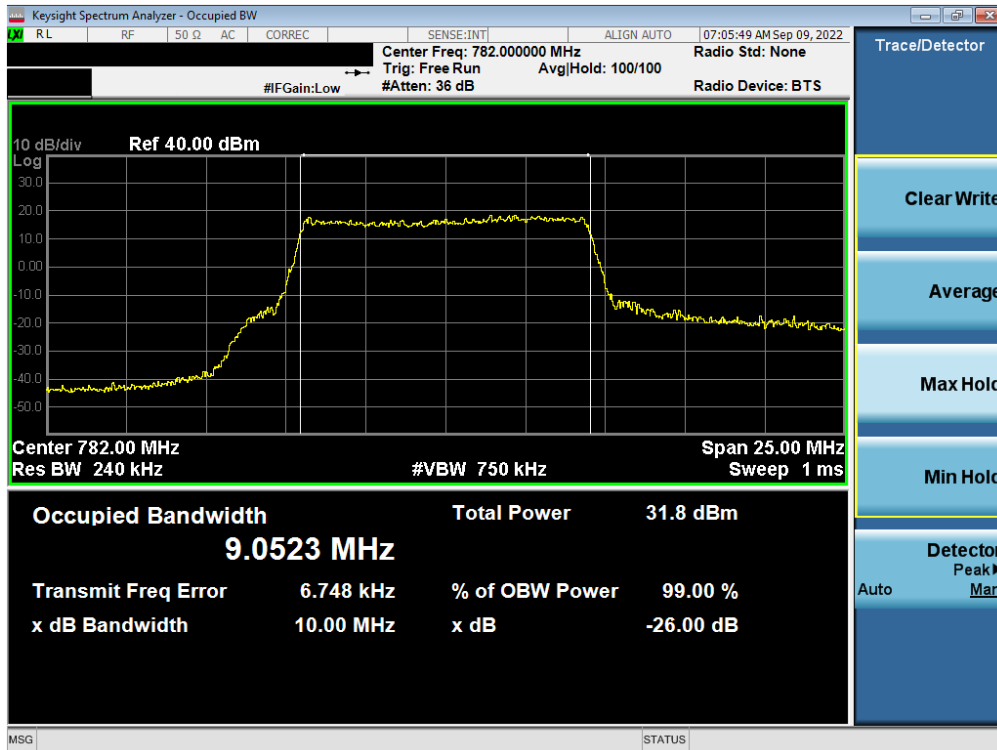
Plot 7-8. Occupied Bandwidth Plot (LTE Band 12 – 1.4MHz 16-QAM - Full RB)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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LTE Band 13

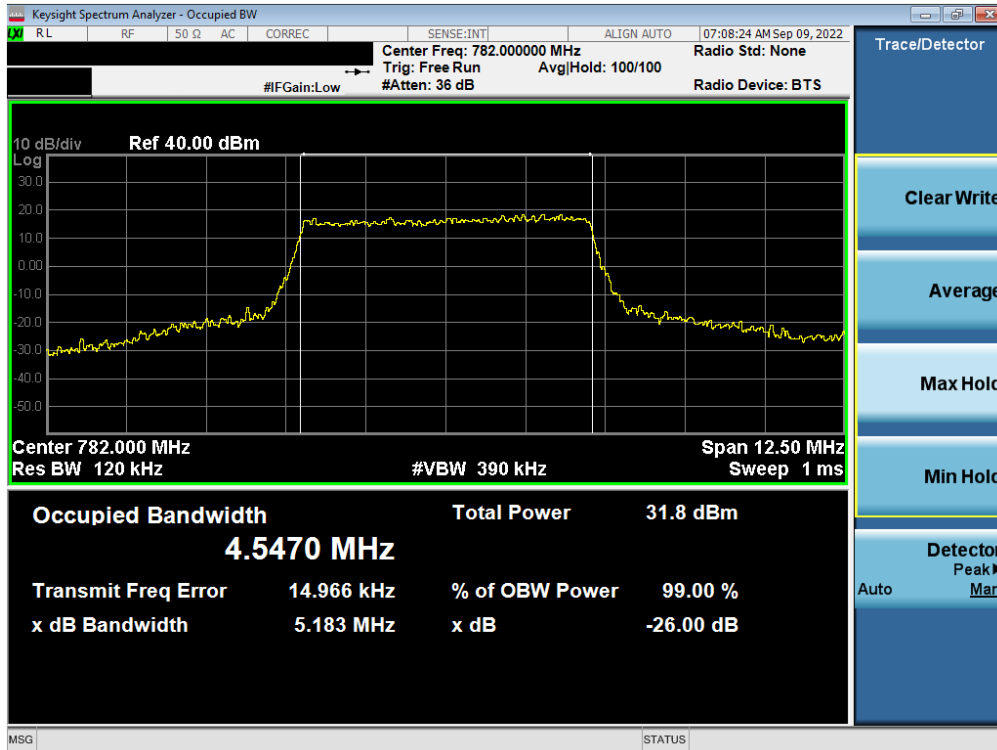


Plot 7-9. Occupied Bandwidth Plot (LTE Band 13 - 10MHz QPSK - Full RB)

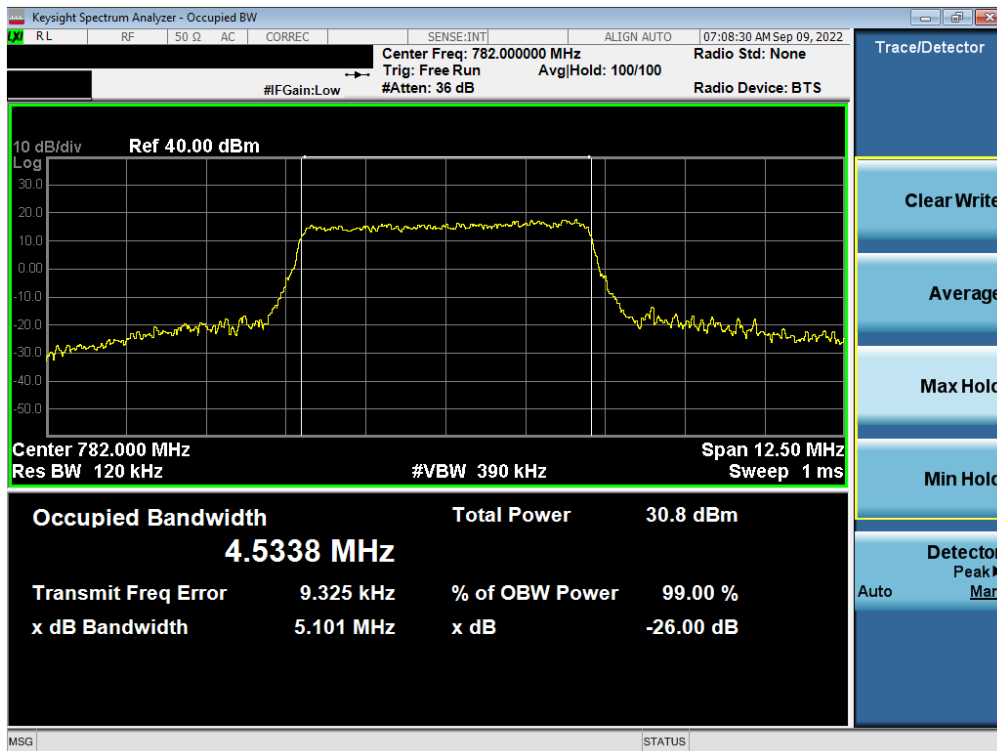


Plot 7-10. Occupied Bandwidth Plot (LTE Band 13 - 10MHz 16-QAM - Full RB)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1M2212080137-03-R1.A3L	Test Dates: 12/13/2022 - 12/20/2022	EUT Type: Portable Handset	Page 18 of 90



Plot 7-11. Occupied Bandwidth Plot (LTE Band 13 - 5MHz QPSK - Full RB)



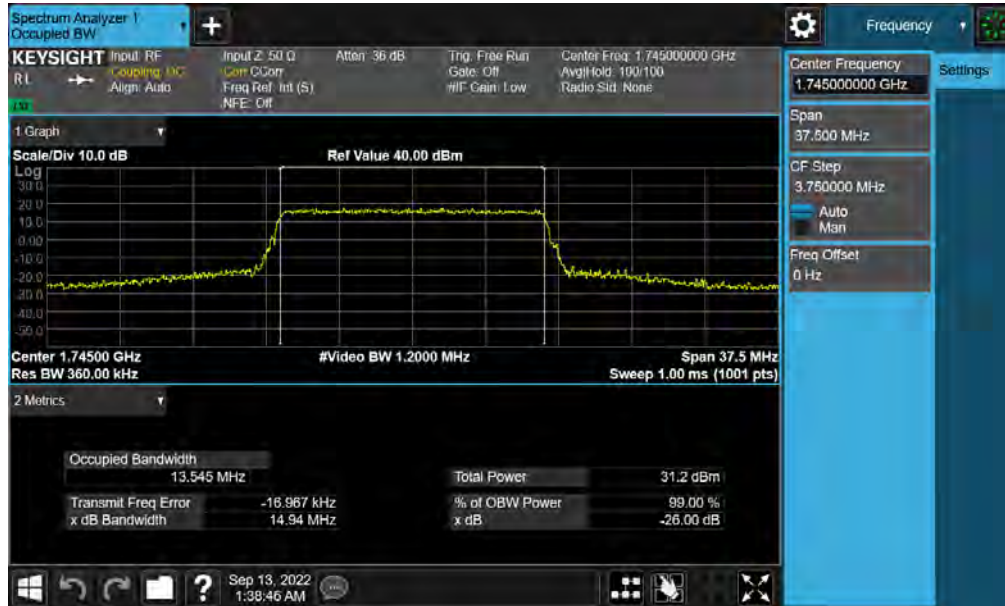
Plot 7-12. Occupied Bandwidth Plot (LTE Band 13 - 5MHz 16-QAM - Full RB)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1M2212080137-03-R1.A3L	Test Dates: 12/13/2022 - 12/20/2022	EUT Type: Portable Handset	Page 19 of 90

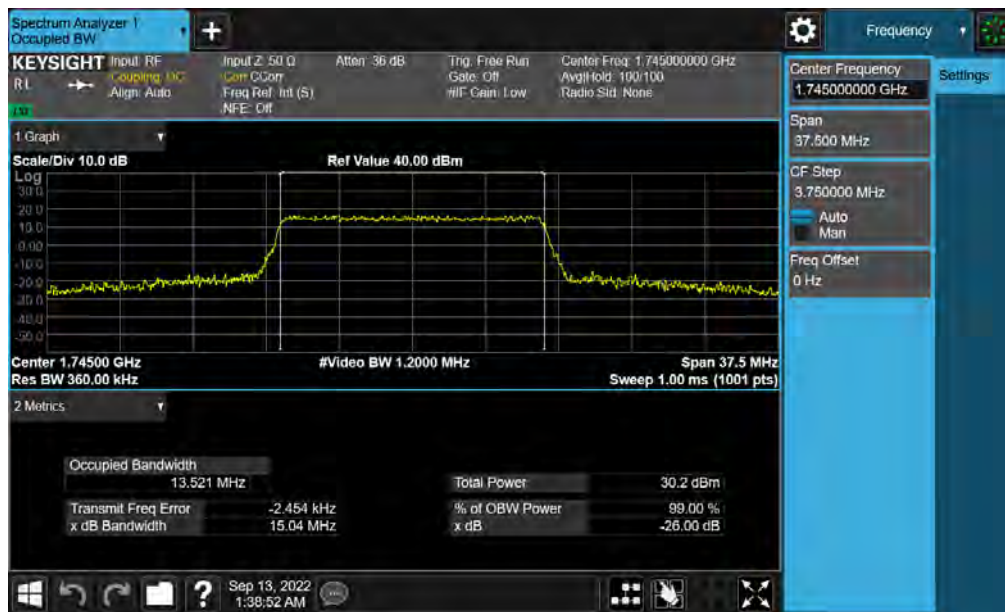
LTE Band 66/4



FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1M2212080137-03-R1.A3L	Test Dates: 12/13/2022 - 12/20/2022	EUT Type: Portable Handset	Page 20 of 90

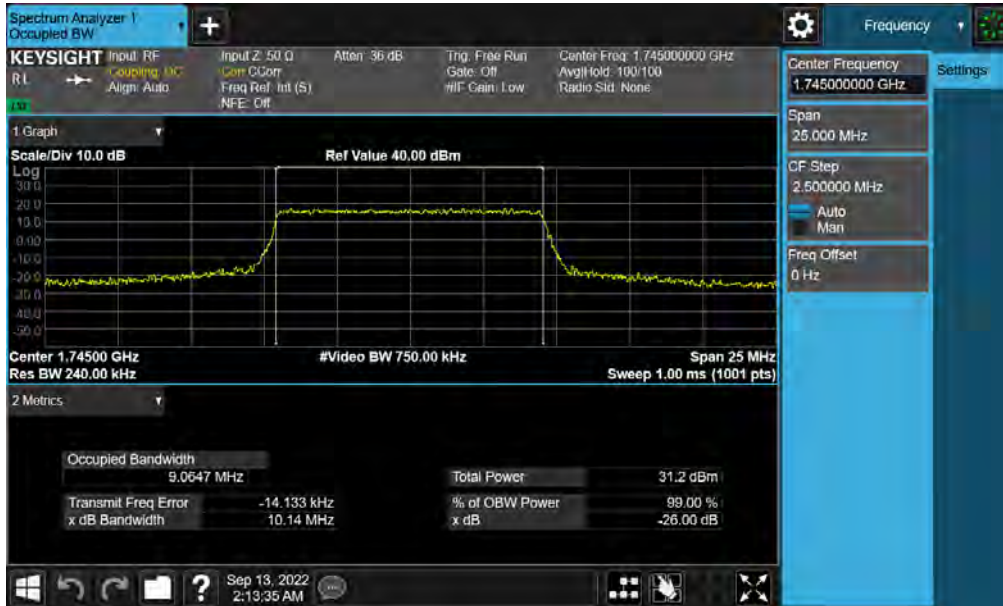


Plot 7-15. Occupied Bandwidth Plot (LTE Band 66/4 - 15MHz QPSK - Full RB)



Plot 7-16. Occupied Bandwidth Plot (LTE Band 66/4 - 15MHz 16-QAM - Full RB)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1M2212080137-03-R1.A3L	Test Dates: 12/13/2022 - 12/20/2022	EUT Type: Portable Handset	Page 21 of 90



Plot 7-17. Occupied Bandwidth Plot (LTE Band 66/4 - 10MHz QPSK - Full RB)



Plot 7-18. Occupied Bandwidth Plot (LTE Band 66/4 - 10MHz 16-QAM - Full RB)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1M2212080137-03-R1.A3L	Test Dates: 12/13/2022 - 12/20/2022	EUT Type: Portable Handset	Page 22 of 90



Plot 7-19. Occupied Bandwidth Plot (LTE Band 66/4 - 5MHz QPSK - Full RB)

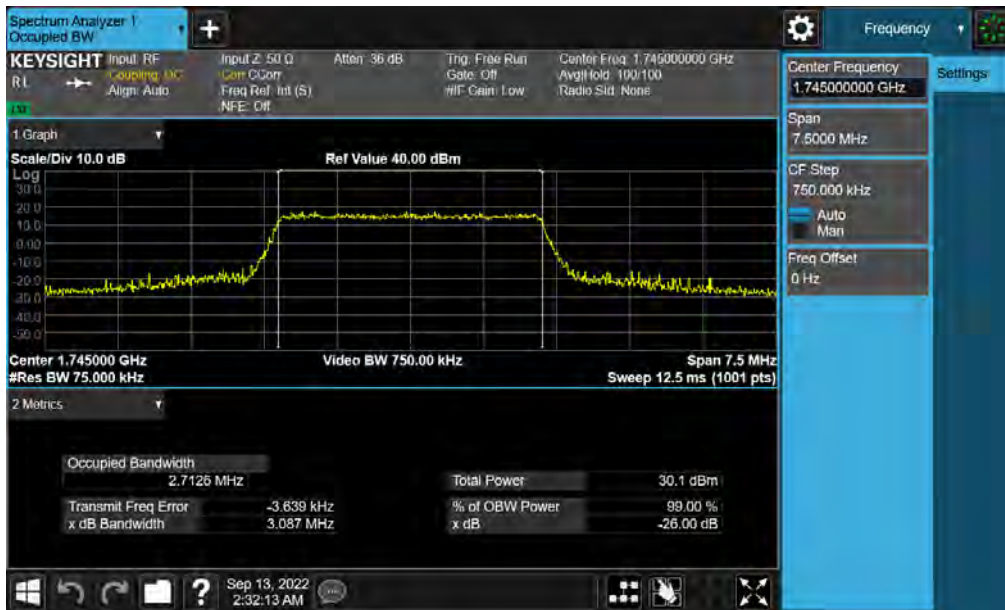


Plot 7-20. Occupied Bandwidth Plot (LTE Band 66/4 - 5MHz 16-QAM - Full RB)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1M2212080137-03-R1.A3L	Test Dates: 12/13/2022 - 12/20/2022	EUT Type: Portable Handset	Page 23 of 90

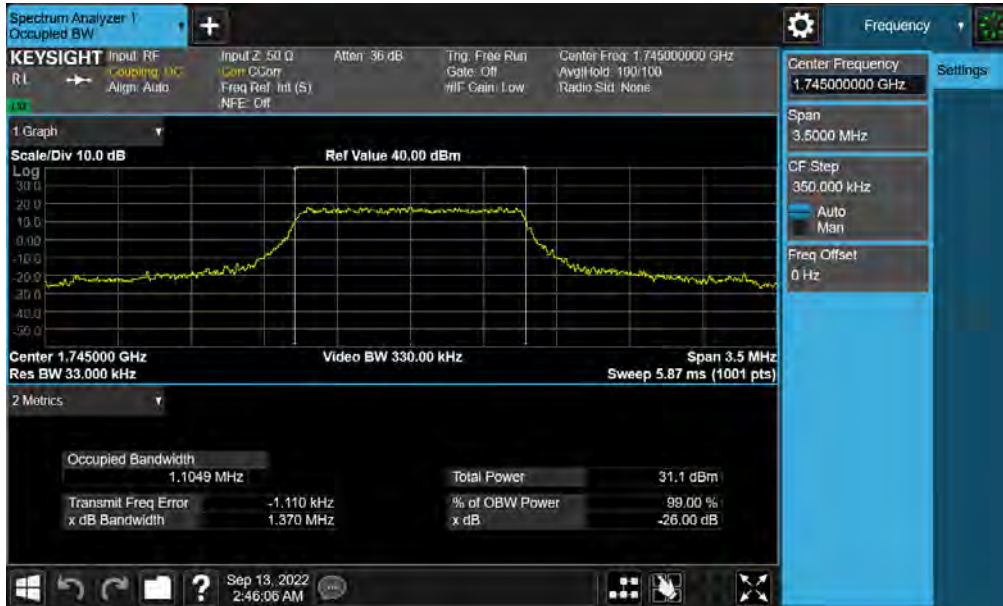


Plot 7-21. Occupied Bandwidth Plot (LTE Band 66/4 - 3MHz QPSK - Full RB)

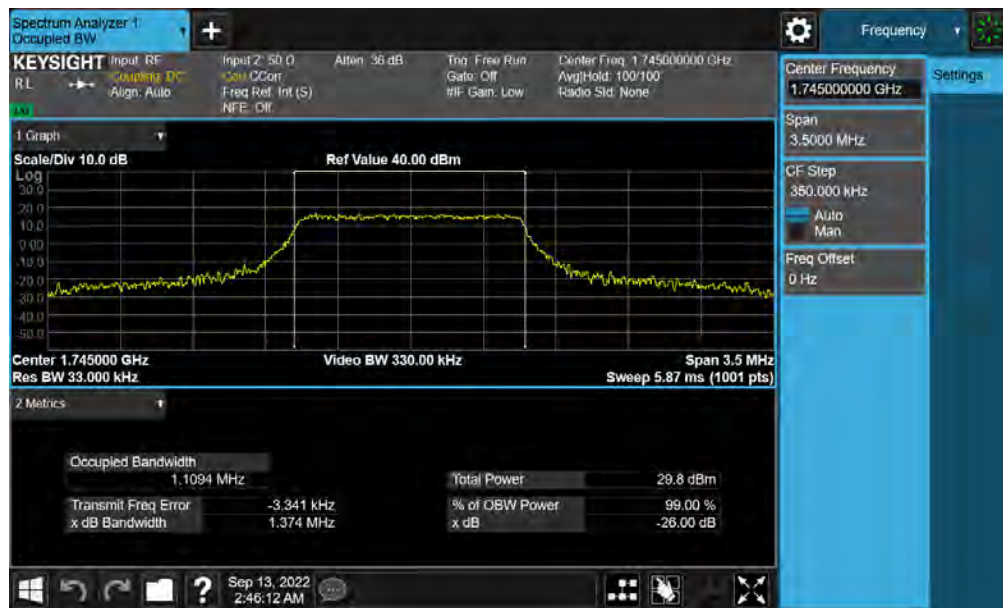


Plot 7-22. Occupied Bandwidth Plot (LTE Band 66/4 - 3MHz 16-QAM - Full RB)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1M2212080137-03-R1.A3L	Test Dates: 12/13/2022 - 12/20/2022	EUT Type: Portable Handset	Page 24 of 90



Plot 7-23. Occupied Bandwidth Plot (LTE Band 66/4 - 1.4MHz QPSK - Full RB)



Plot 7-24. Occupied Bandwidth Plot (LTE Band 66/4 - 1.4MHz 16-QAM - Full RB)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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7.4 Spurious and Harmonic Emissions at Antenna Terminal

Test Overview

The level of the carrier and the various conducted spurious and harmonic frequencies is measured by means of a calibrated spectrum analyzer. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic. All out of band emissions are measured with a spectrum analyzer connected to the antenna terminal of the EUT while the EUT is operating at maximum power, and at the appropriate frequencies. All data rates were investigated to determine the worst case configuration. All modes of operation were investigated and the worst case configuration results are reported in this section.

The minimum permissible attenuation level of any spurious emission is $43 + 10 \log_{10}(P_{[Watts]})$, where P is the transmitter power in Watts.

Test Procedure Used

ANSI C63.26-2015 – Section 5.7.4

Test Settings

1. Start frequency was set to 30MHz and stop frequency was set to 18GHz (separated into at least two plots per channel)
2. RBW \geq 100kHz
3. VBW \geq 3 x RBW
4. Detector = RMS
5. Trace mode = max hold
6. Sweep time = auto couple
7. The trace was allowed to stabilize

Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.

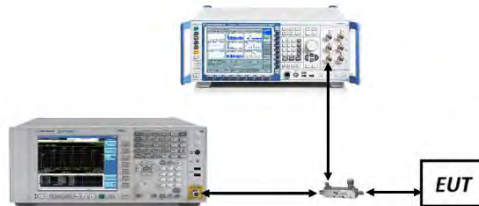


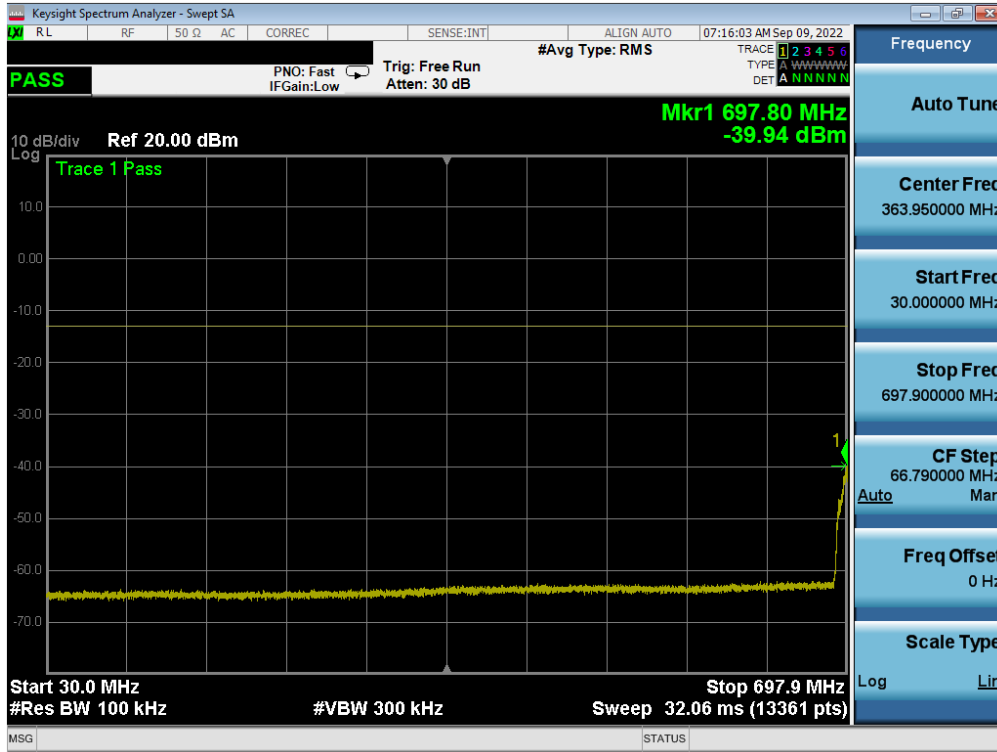
Figure 7-3. Test Instrument & Measurement Setup

Test Notes

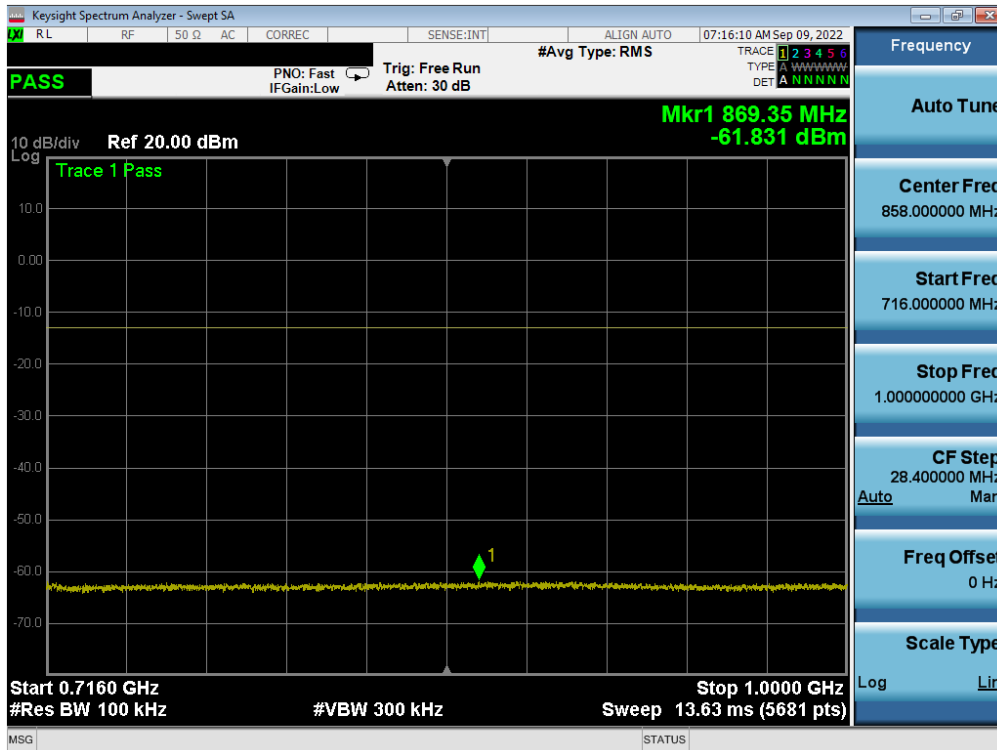
Per Part 27 and RSS-139, compliance with the applicable limits is based on the use of measurement instrumentation employing a resolution bandwidth 100 kHz or greater for measurements below 1GHz.

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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LTE Band 12

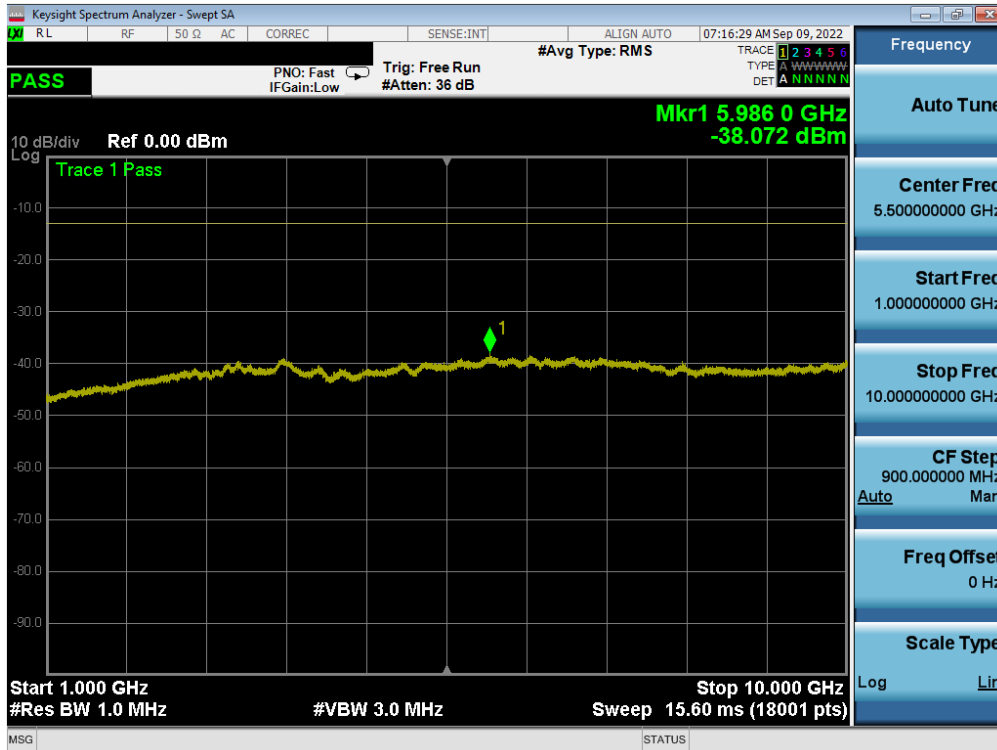


Plot 7-25. Conducted Spurious Plot (LTE Band 12 - 10MHz QPSK - 1 RB - Low Channel)

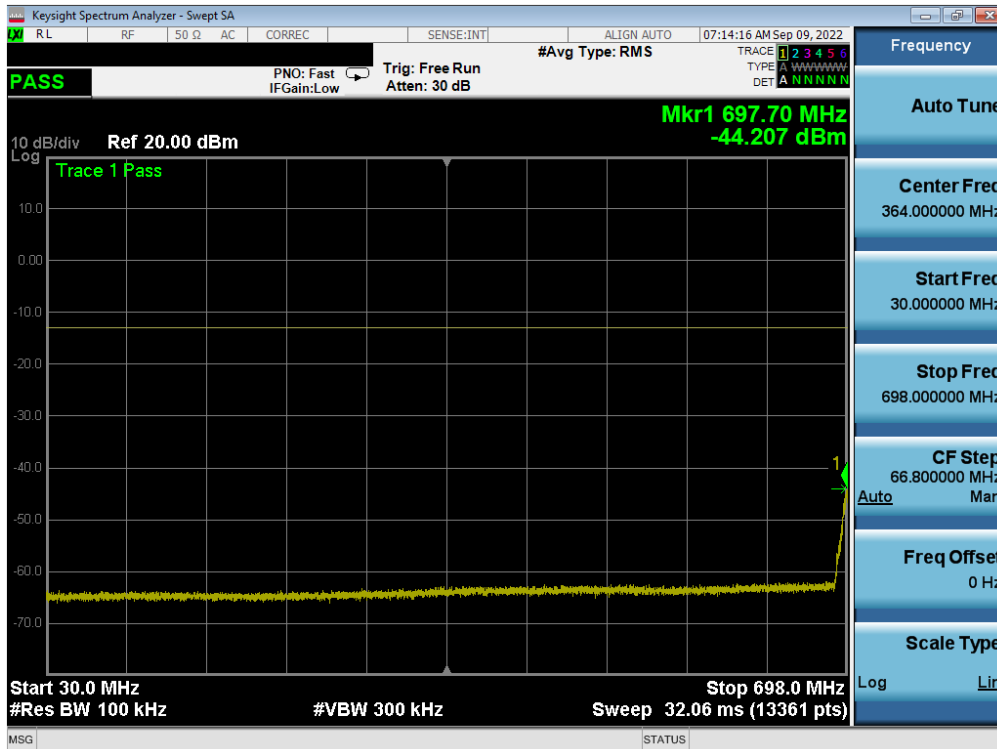


Plot 7-26. Conducted Spurious Plot (LTE Band 12 - 10MHz QPSK - 1 RB - Low Channel)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1M2212080137-03-R1.A3L	Test Dates: 12/13/2022 - 12/20/2022	EUT Type: Portable Handset	Page 27 of 90

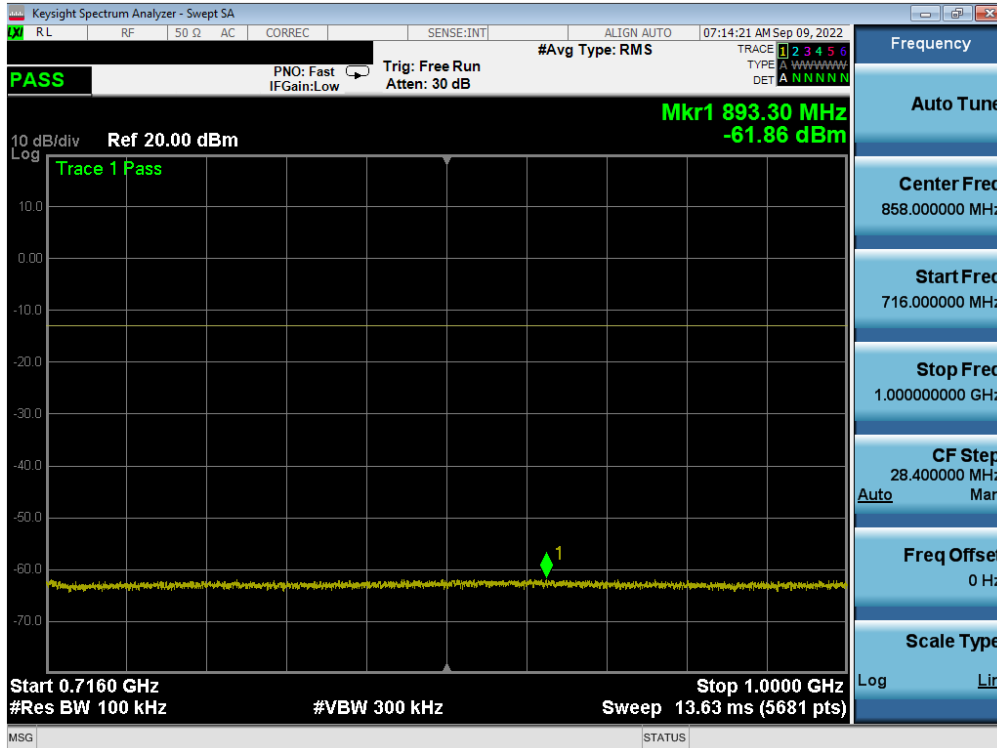


Plot 7-27. Conducted Spurious Plot (LTE Band 12 - 10MHz QPSK - 1 RB - Low Channel)

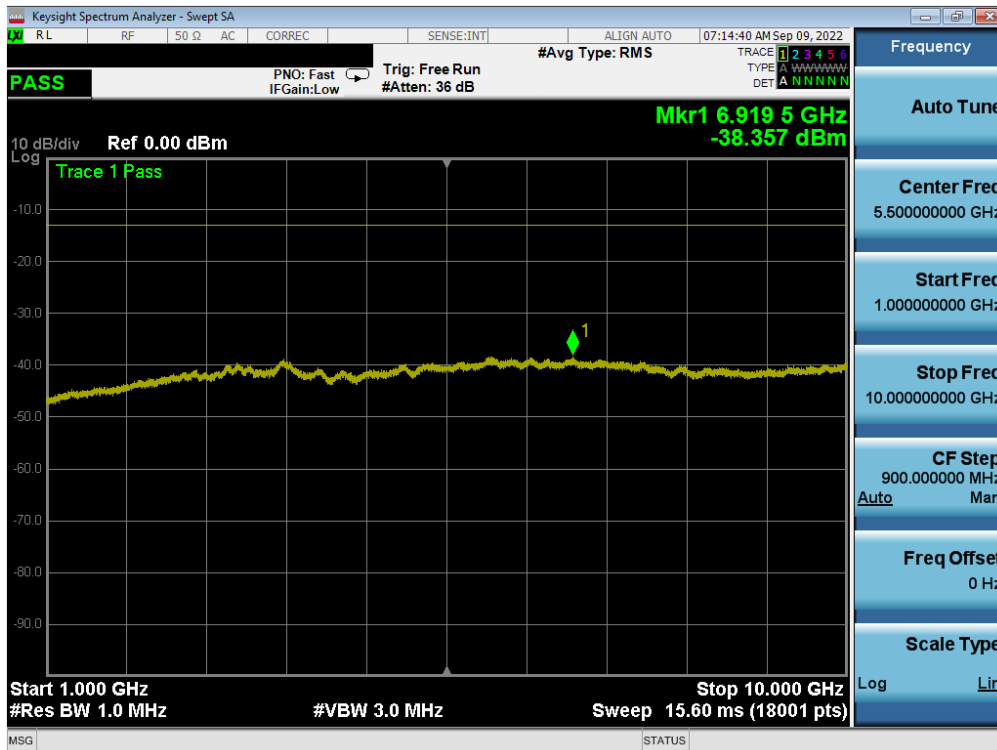


Plot 7-28. Conducted Spurious Plot (LTE Band 12 - 10MHz QPSK - 1 RB - Mid Channel)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1M2212080137-03-R1.A3L	Test Dates: 12/13/2022 - 12/20/2022	EUT Type: Portable Handset	Page 28 of 90

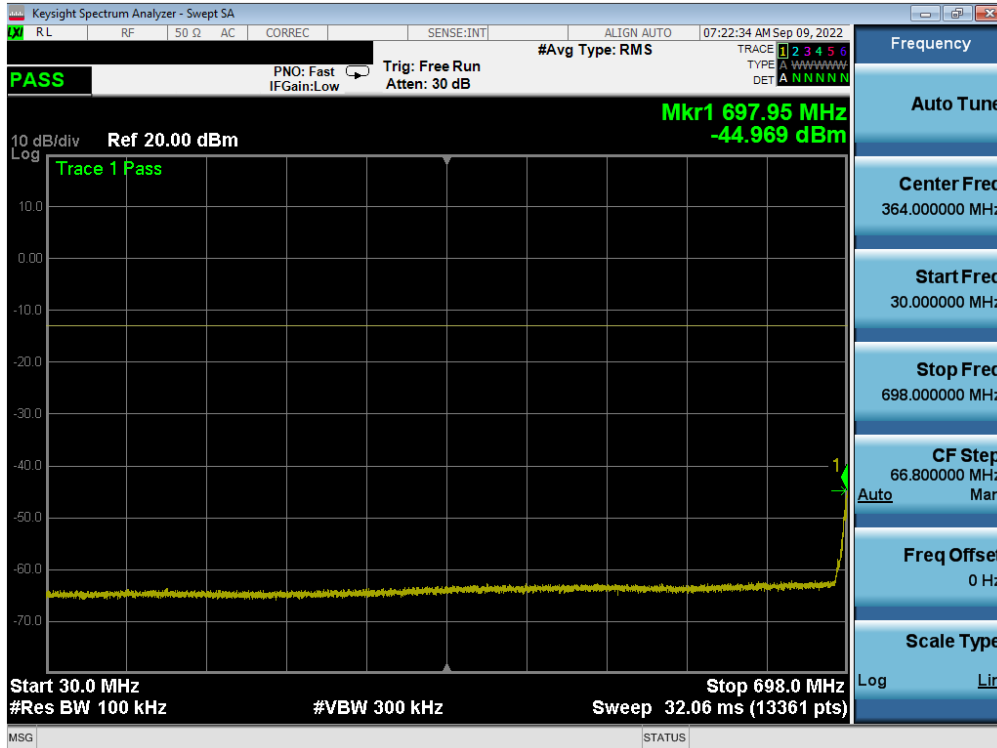


Plot 7-29. Conducted Spurious Plot (LTE Band 12 - 10MHz QPSK - 1 RB - Mid Channel)

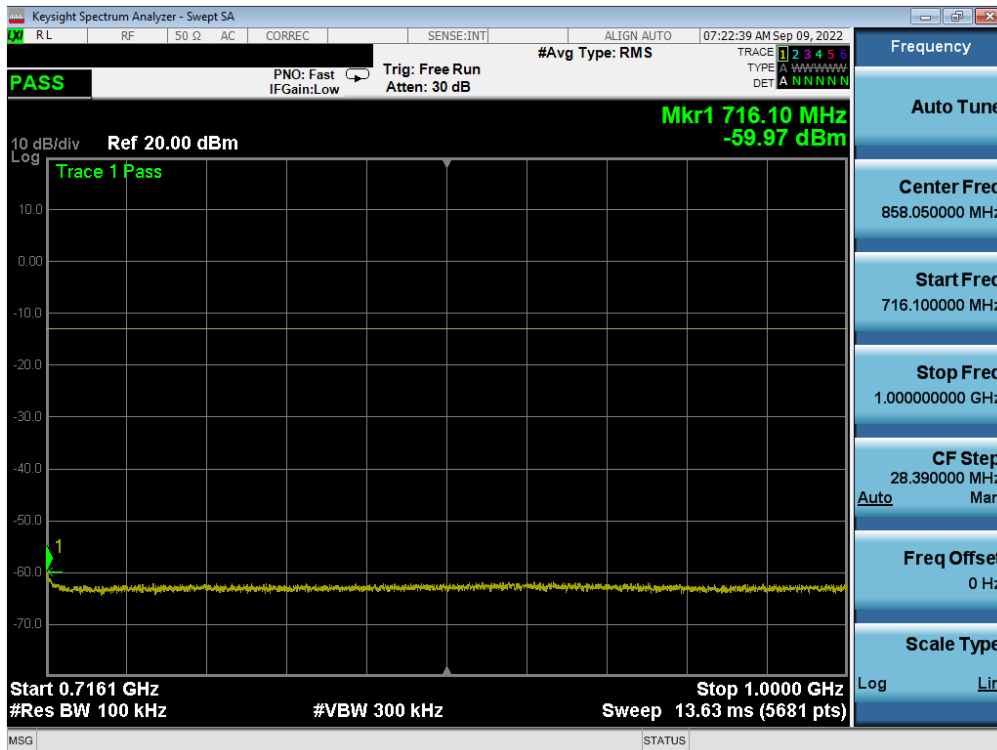


Plot 7-30. Conducted Spurious Plot (LTE Band 12 - 10MHz QPSK - 1 RB - Mid Channel)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1M2212080137-03-R1.A3L	Test Dates: 12/13/2022 - 12/20/2022	EUT Type: Portable Handset	Page 29 of 90

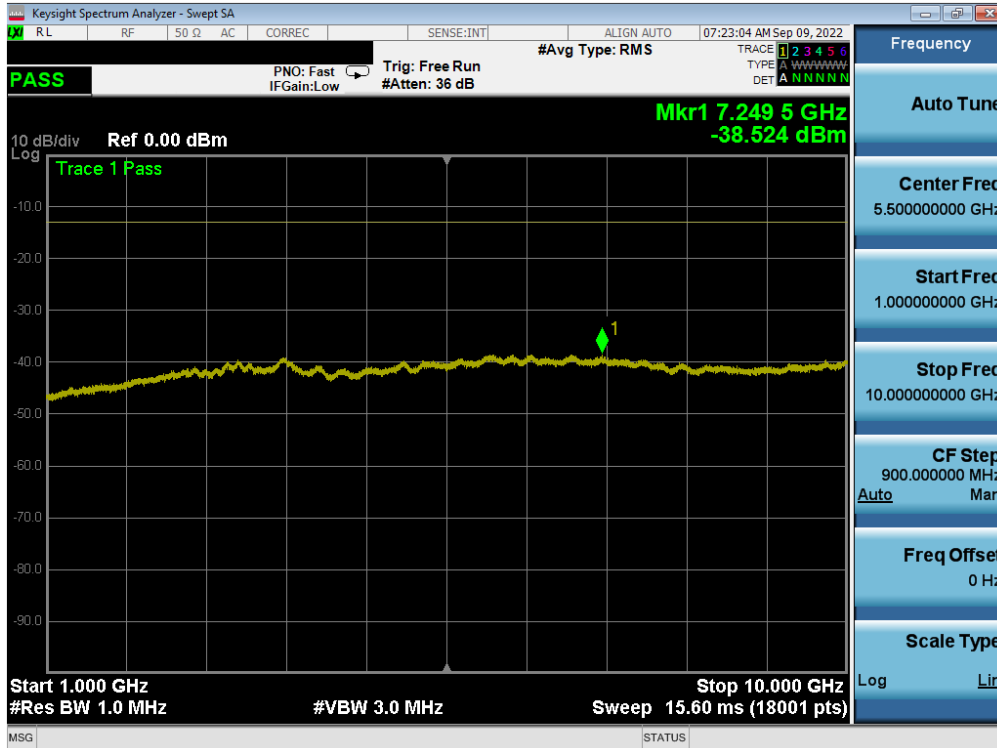


Plot 7-31. Conducted Spurious Plot (LTE Band 12 - 10MHz QPSK - 1 RB - High Channel)



Plot 7-32. Conducted Spurious Plot (LTE Band 12 - 10MHz QPSK - 1 RB - High Channel)

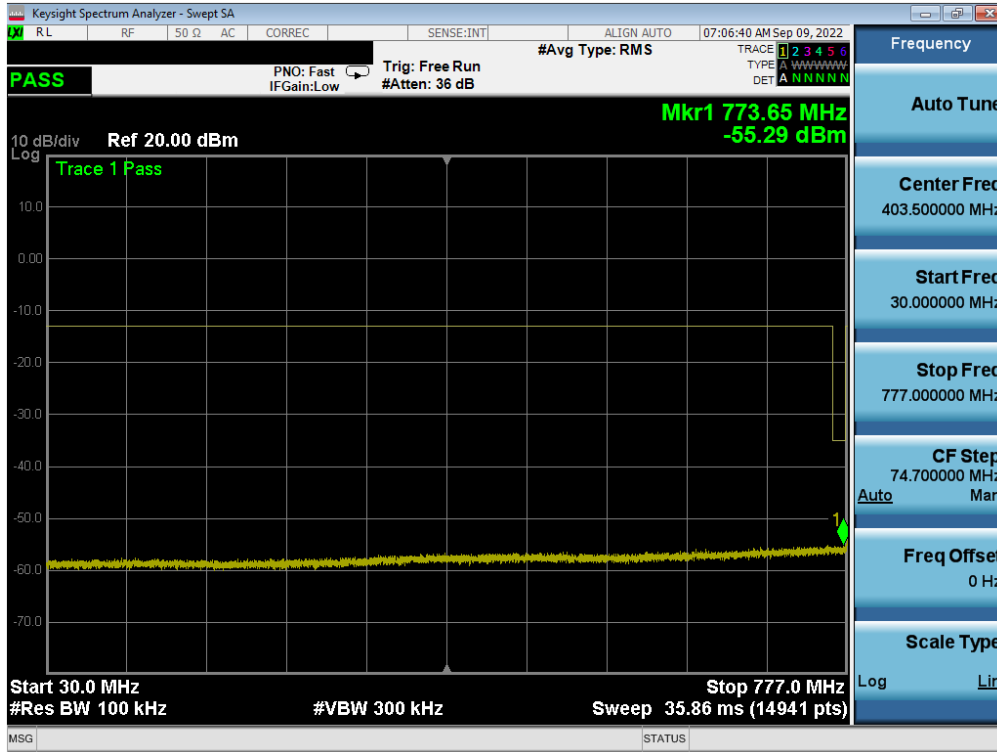
FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1M2212080137-03-R1.A3L	Test Dates: 12/13/2022 - 12/20/2022	EUT Type: Portable Handset	Page 30 of 90



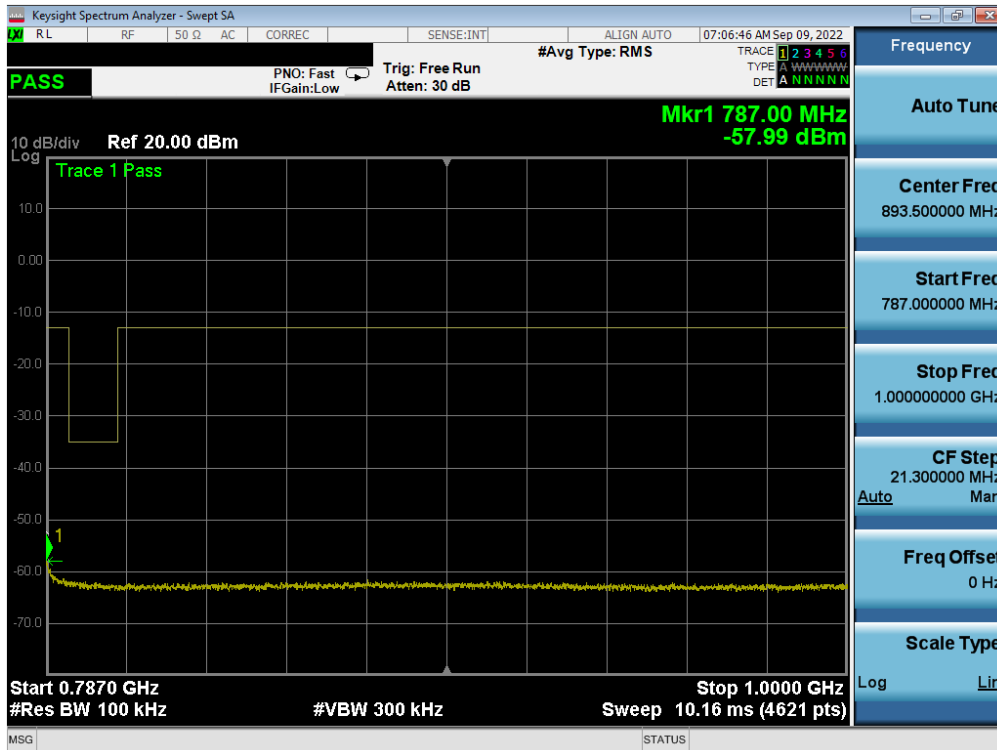
Plot 7-33. Conducted Spurious Plot (LTE Band 12 - 10MHz QPSK - 1 RB - High Channel)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1M2212080137-03-R1.A3L	Test Dates: 12/13/2022 - 12/20/2022	EUT Type: Portable Handset	Page 31 of 90

LTE Band 13

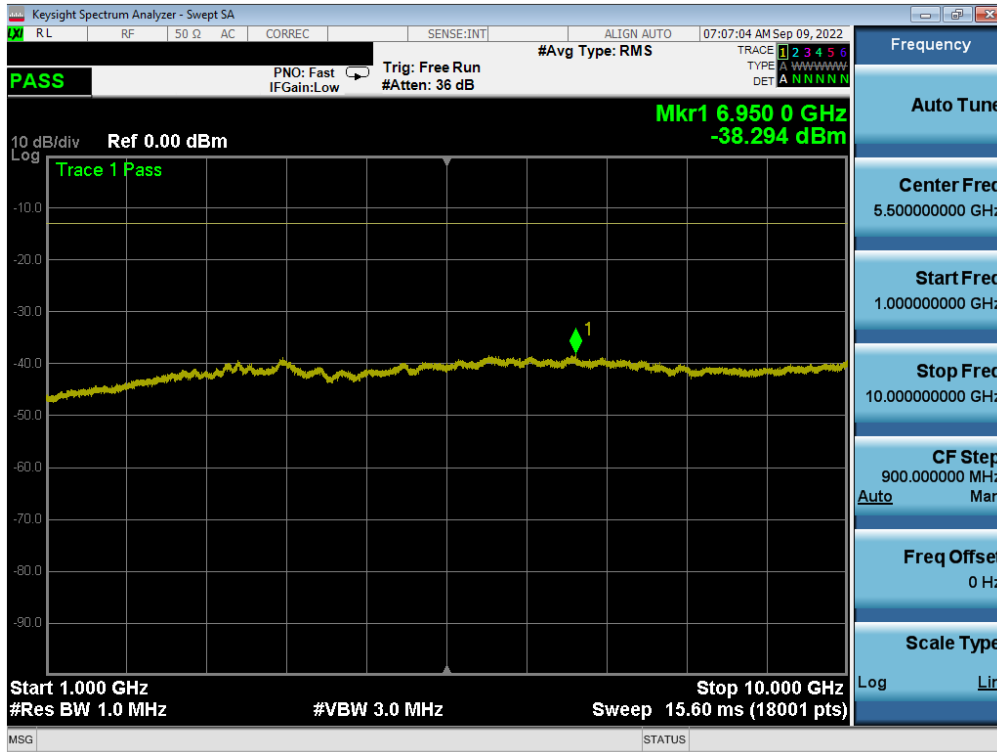


Plot 7-34. Conducted Spurious Plot (LTE Band 13 - 10MHz QPSK - 1 RB)



Plot 7-35. Conducted Spurious Plot (LTE Band 13 - 10MHz QPSK - 1 RB)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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Plot 7-36. Conducted Spurious Plot (LTE Band 13 - 10MHz QPSK - 1 RB)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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LTE Band 66/4



Plot 7-37. Conducted Spurious Plot (LTE Band 66/4 - 20MHz QPSK - 1 RB - Low Channel)

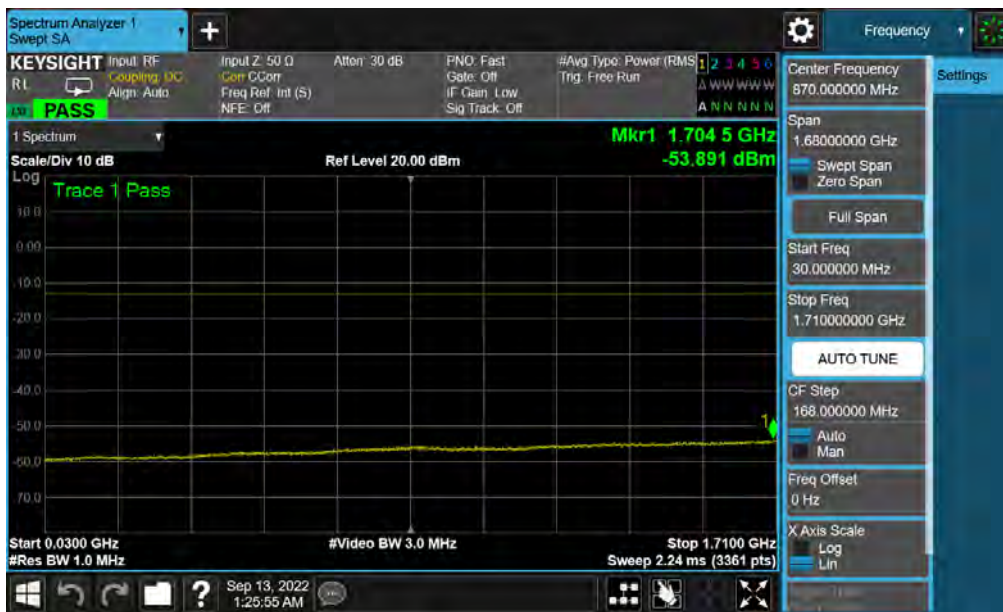


Plot 7-38. Conducted Spurious Plot (LTE Band 66/4 - 20MHz QPSK - 1 RB - Low Channel)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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Plot 7-39. Conducted Spurious Plot (LTE Band 66/4 - 20MHz QPSK - 1 RB - Low Channel)



Plot 7-40. Conducted Spurious Plot (LTE Band 66/4 - 20MHz QPSK - 1 RB - Mid Channel)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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Plot 7-41. Conducted Spurious Plot (LTE Band 66/4 - 20MHz QPSK - 1 RB - Mid Channel)



Plot 7-42. Conducted Spurious Plot (LTE Band 66/4 - 20MHz QPSK - 1 RB - Mid Channel)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1M2212080137-03-R1.A3L	Test Dates: 12/13/2022 - 12/20/2022	EUT Type: Portable Handset	Page 37 of 90



Plot 7-45. Conducted Spurious Plot (LTE Band 66/4 - 20MHz QPSK - 1 RB - High Channel)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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7.5 Band Edge Emissions at Antenna Terminal

Test Overview

All out of band emissions are measured with a spectrum analyzer connected to the antenna terminal of the EUT while the EUT is operating at its maximum duty cycle, at maximum power, and at the appropriate frequencies. All data rates were investigated to determine the worst-case configuration. All modes of operation were investigated and the worst-case configuration results are reported in this section.

The minimum permissible attenuation level of any spurious emission is $43 + 10 \log_{10}(P_{\text{Watts}})$, where P is the transmitter power in Watts.

Test Procedure Used

ANSI C63.26-2015 – Section 5.7.3

Test Settings

1. Start and stop frequency were set such that the band edge would be placed in the center of the plot
2. Span was set large enough so as to capture all out of band emissions near the band edge
3. RBW \geq 1% of the emission bandwidth
4. VBW \geq 3 x RBW
5. Detector = RMS
6. Number of sweep points \geq 2 x Span/RBW
7. Trace mode = trace average for continuous emissions, max hold for pulse emissions
8. Sweep time = auto couple
9. The trace was allowed to stabilize

Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.

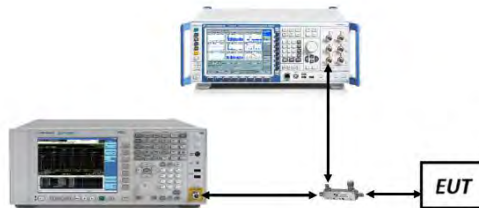


Figure 7-4. Test Instrument & Measurement Setup

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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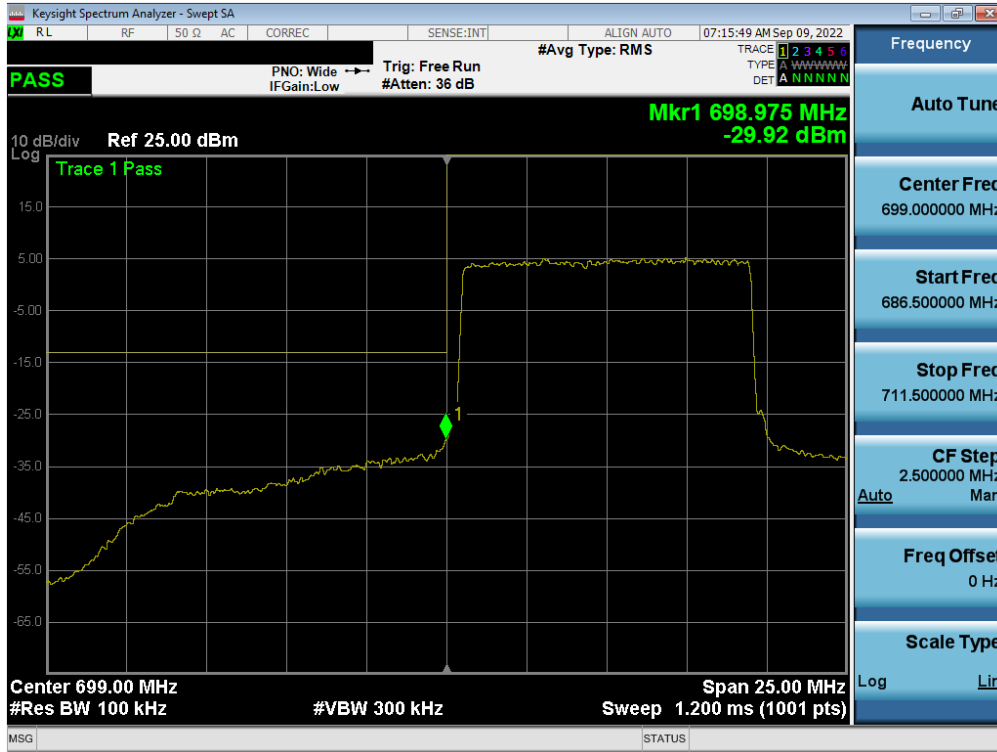


Test Notes

1. Per 27.53(h) for AWS band operation, in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed to demonstrate compliance with the out-of-band emissions limit. The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emission are attenuated at least 26 dB below the transmitter power.
2. Per 27.53(g) for operations in the 663 - 698 MHz and 698 – 746MHz bands, in the 100 kHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least 30 kHz may be employed to demonstrate compliance with the out-of-band emissions limit.
3. Per 27.53(c)(5) for operations in the 776-788 MHz band, in the 100 kHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least 30 kHz may be employed to demonstrate compliance with the out-of-band emissions limit.
4. For all plots showing emissions in the 763 – 775MHz and 793 – 805MHz band, the FCC limit per 27.53(c)(4) is $65 + 10 \log_{10}(P) = -35\text{dBm}$ in a 6.25kHz bandwidth.

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LTE Band 12

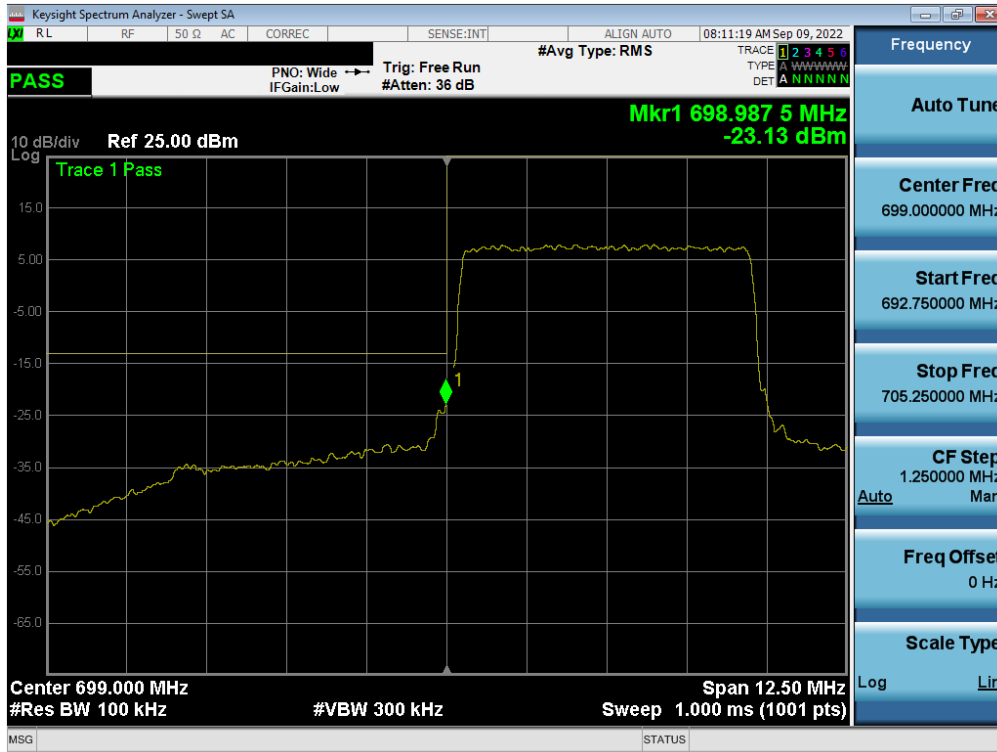


Plot 7-46. Lower Band Edge Plot (LTE Band 12 - 10MHz QPSK – Full RB)



Plot 7-47. Upper Band Edge Plot (LTE Band 12 - 10MHz QPSK – Full RB)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1M2212080137-03-R1.A3L	Test Dates: 12/13/2022 - 12/20/2022	EUT Type: Portable Handset	Page 41 of 90



Plot 7-48. Lower Band Edge Plot (LTE Band 12 - 5MHz QPSK – Full RB)

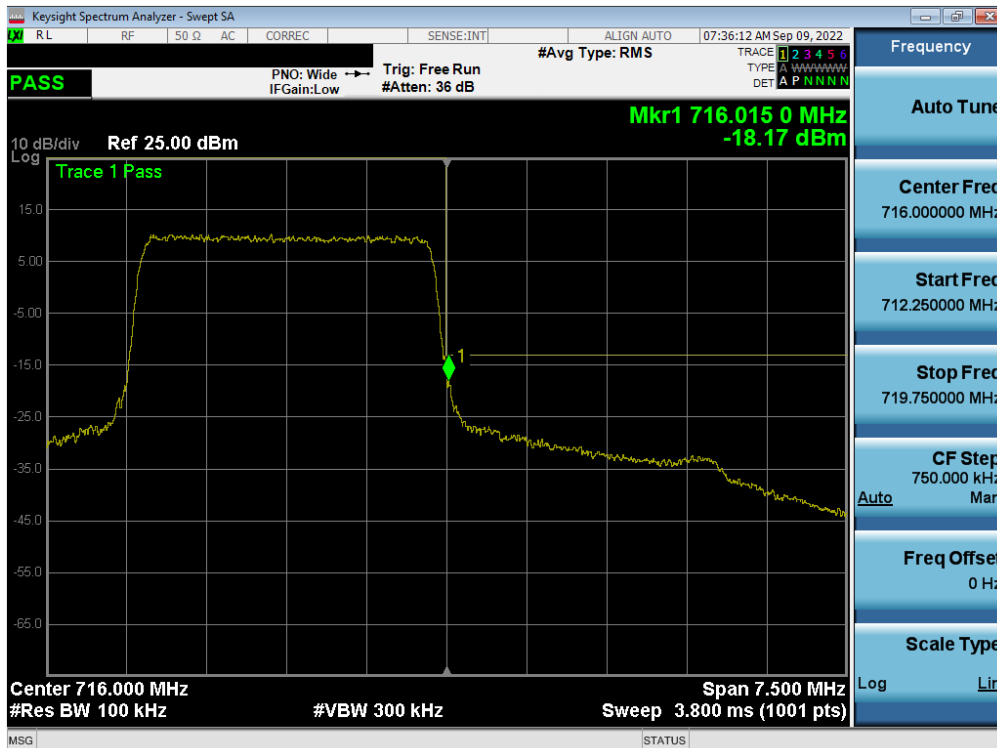


Plot 7-49. Upper Band Edge Plot (LTE Band 12 - 5MHz QPSK – Full RB)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1M2212080137-03-R1.A3L	Test Dates: 12/13/2022 - 12/20/2022	EUT Type: Portable Handset	Page 42 of 90

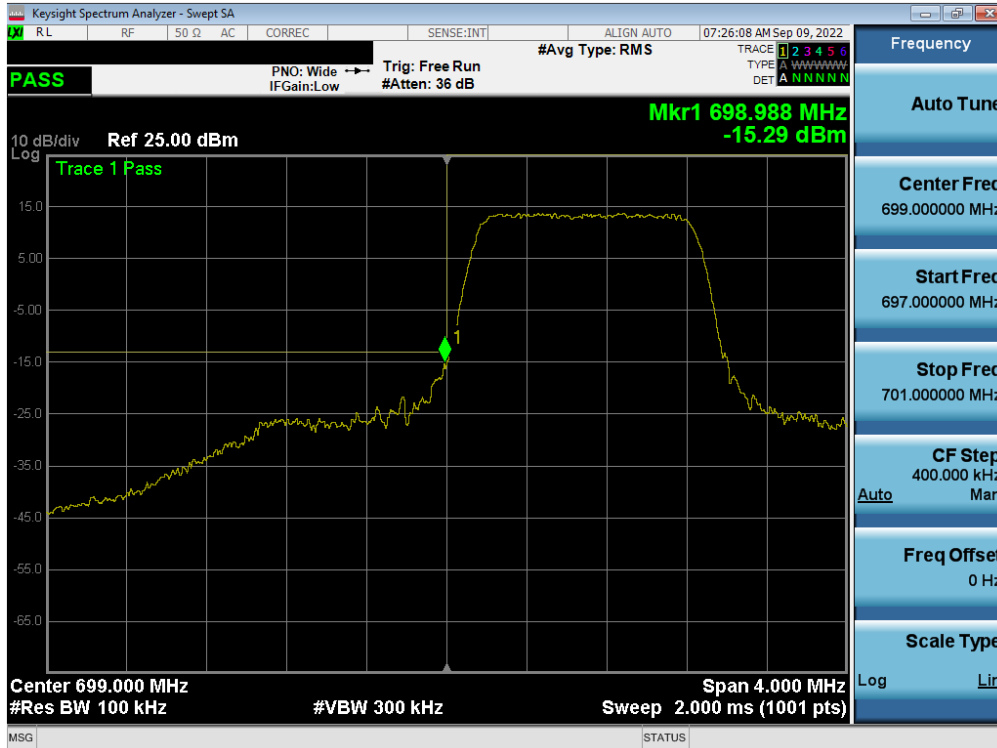


Plot 7-50. Lower Band Edge Plot (LTE Band 12 - 3MHz QPSK – Full RB)

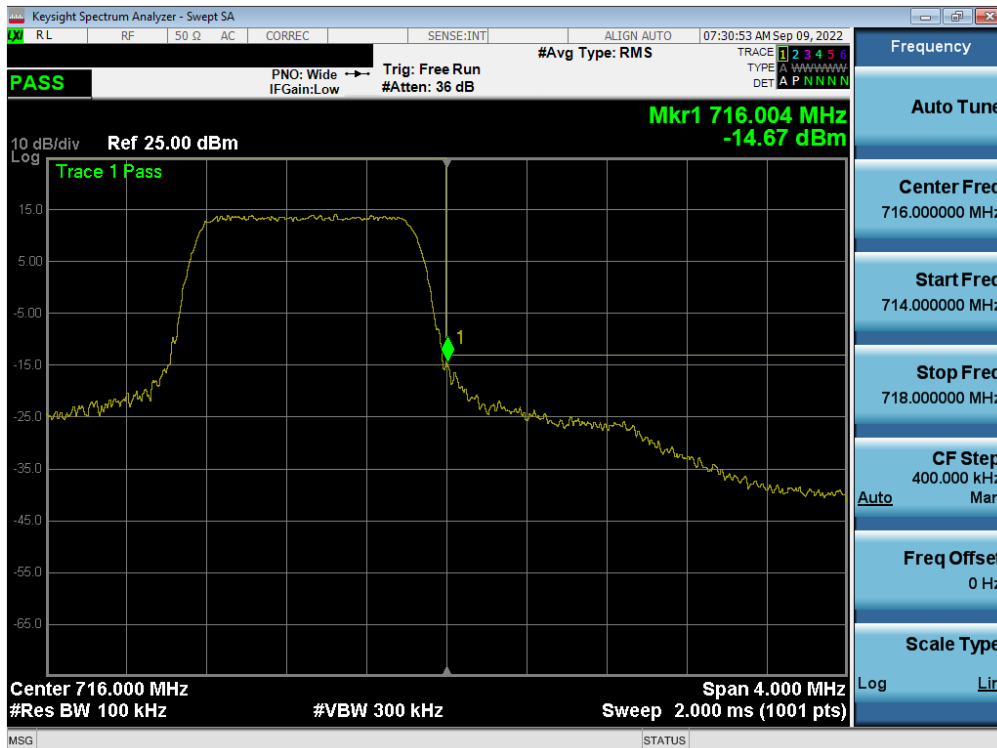


Plot 7-51. Upper Band Edge Plot (LTE Band 12 - 3MHz QPSK – Full RB)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1M2212080137-03-R1.A3L	Test Dates: 12/13/2022 - 12/20/2022	EUT Type: Portable Handset	Page 43 of 90



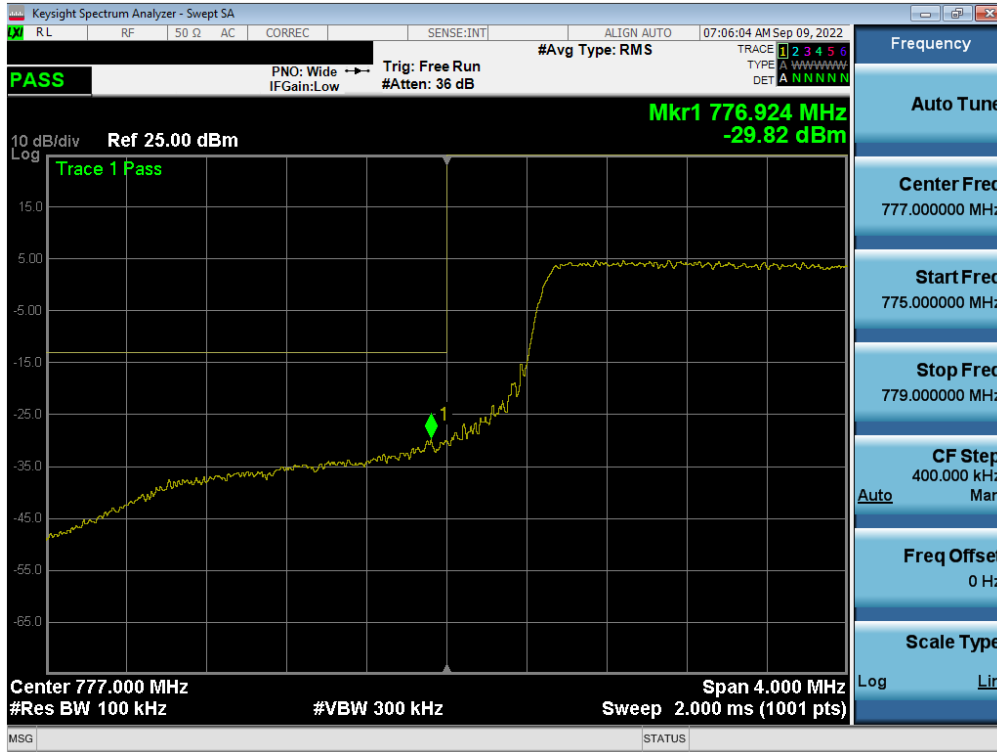
Plot 7-52. Lower Band Edge Plot (LTE Band 12 – 1.4MHz QPSK – Full RB)



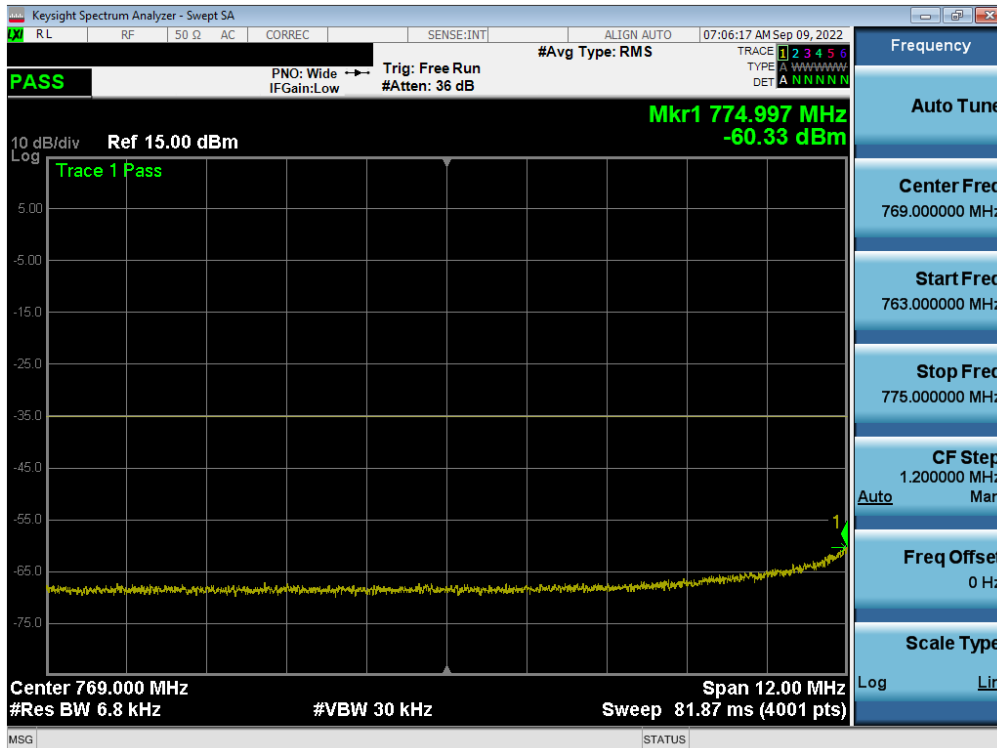
Plot 7-53. Upper Band Edge Plot (LTE Band 12 – 1.4MHz QPSK – Full RB)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1M2212080137-03-R1.A3L	Test Dates: 12/13/2022 - 12/20/2022	EUT Type: Portable Handset	Page 44 of 90

LTE Band 13



Plot 7-54. Lower Band Edge Plot (LTE Band 13 - 10MHz QPSK – Full RB)

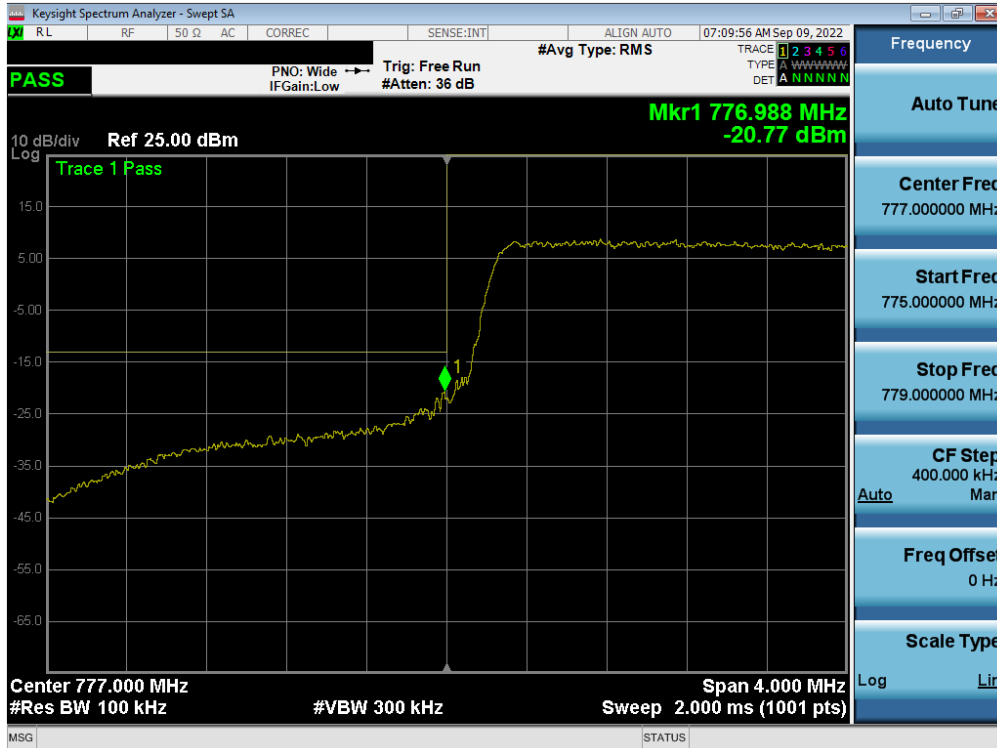


Plot 7-55. Lower Emission Mask Plot (LTE Band 13 - 10MHz QPSK – Full RB)

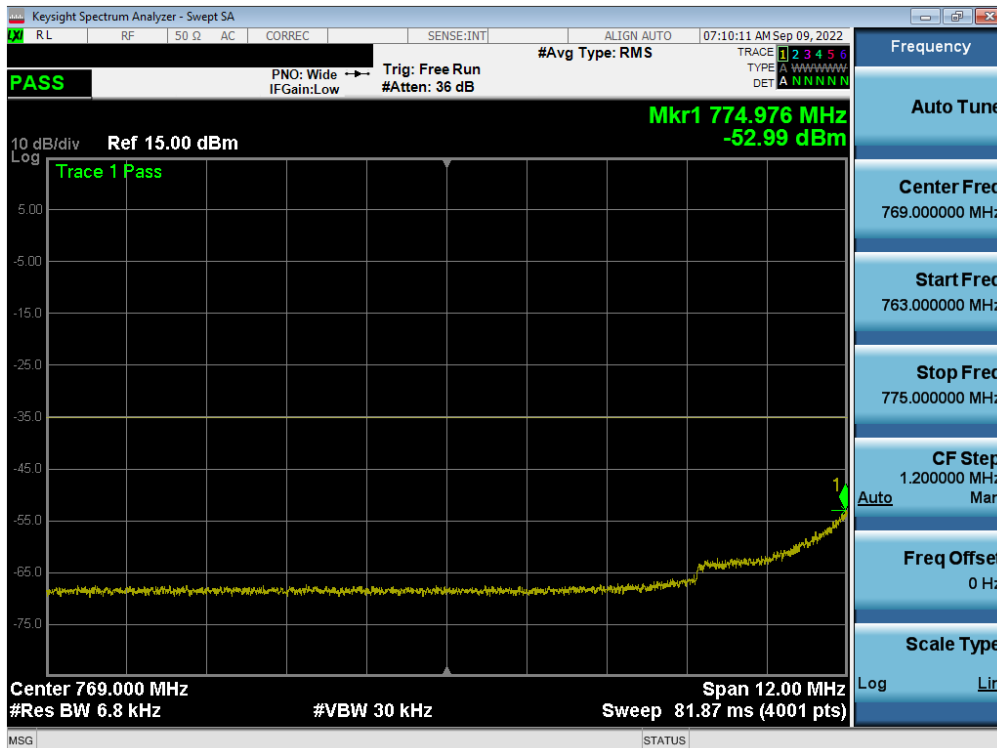
FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1M2212080137-03-R1.A3L	Test Dates: 12/13/2022 - 12/20/2022	EUT Type: Portable Handset	Page 45 of 90



FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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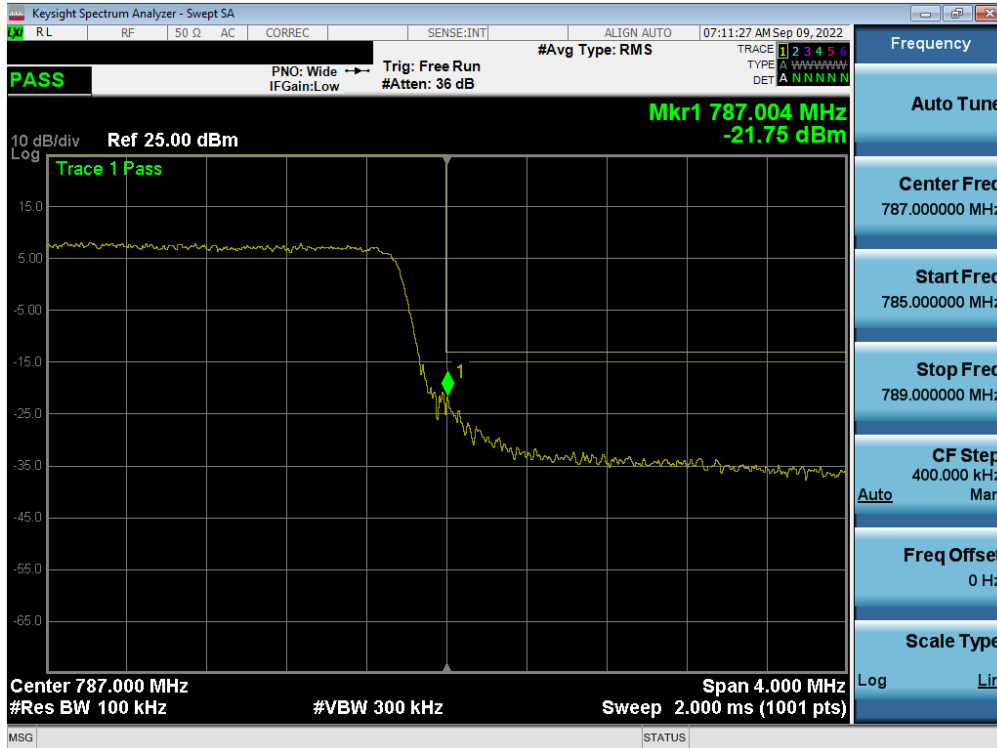


Plot 7-58. Lower Band Edge Plot (LTE Band 13 - 5MHz QPSK – Full RB)

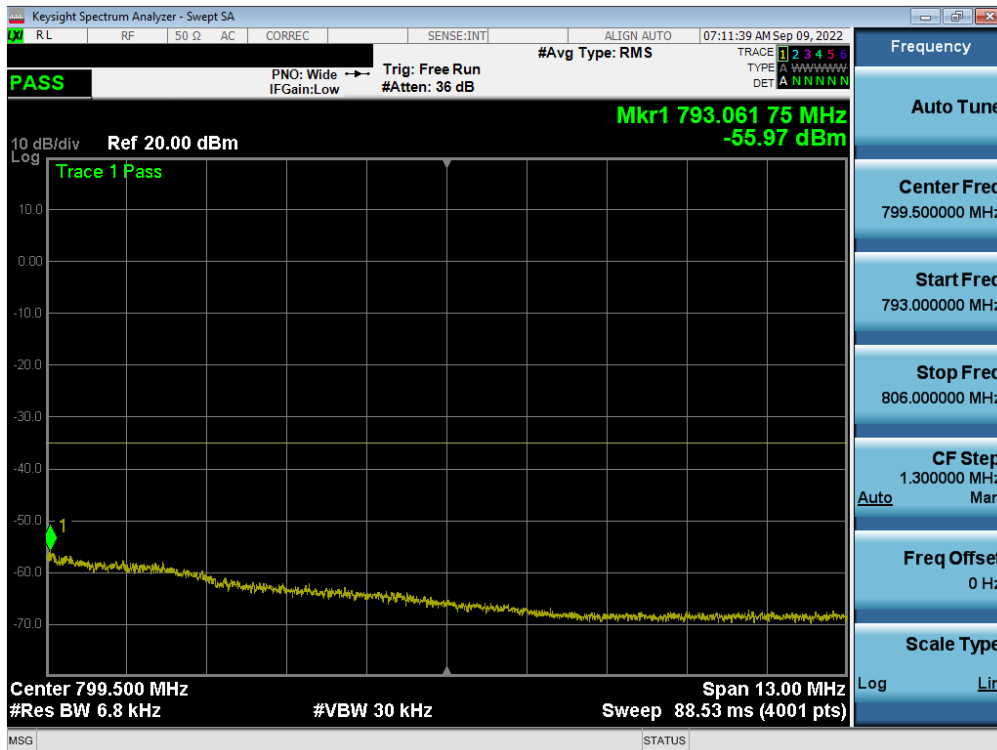


Plot 7-59. Lower Emission Mask Plot (LTE Band 13 - 5MHz QPSK – Full RB)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1M2212080137-03-R1.A3L	Test Dates: 12/13/2022 - 12/20/2022	EUT Type: Portable Handset	Page 47 of 90



Plot 7-60. Upper Band Edge Plot (LTE Band 13 - 5MHz QPSK – Full RB)



Plot 7-61. Upper Emission Mask Plot (LTE Band 13 - 5MHz QPSK – Full RB)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1M2212080137-03-R1.A3L	Test Dates: 12/13/2022 - 12/20/2022	EUT Type: Portable Handset	Page 48 of 90

LTE Band 66/4



FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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Plot 7-64. Upper Band Edge Plot (LTE Band 4 - 20MHz QPSK – Full RB)



Plot 7-65. Upper Extended Band Edge Plot (LTE Band 4 - 20MHz QPSK – Full RB)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1M2212080137-03-R1.A3L	Test Dates: 12/13/2022 - 12/20/2022	EUT Type: Portable Handset	Page 50 of 90



Plot 7-66. Upper Band Edge Plot (LTE Band 66 - 20MHz QPSK – Full RB)



Plot 7-67. Channel Edge Plot (LTE Band 66 - 20MHz QPSK – Full RB)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1M2212080137-03-R1.A3L	Test Dates: 12/13/2022 - 12/20/2022	EUT Type: Portable Handset	Page 51 of 90



Plot 7-68. Lower Band Edge Plot (LTE Band 66/4 - 15MHz QPSK – Full RB)



Plot 7-69. Lower Extended Band Edge Plot (LTE Band 66/4 - 15MHz QPSK – Full RB)

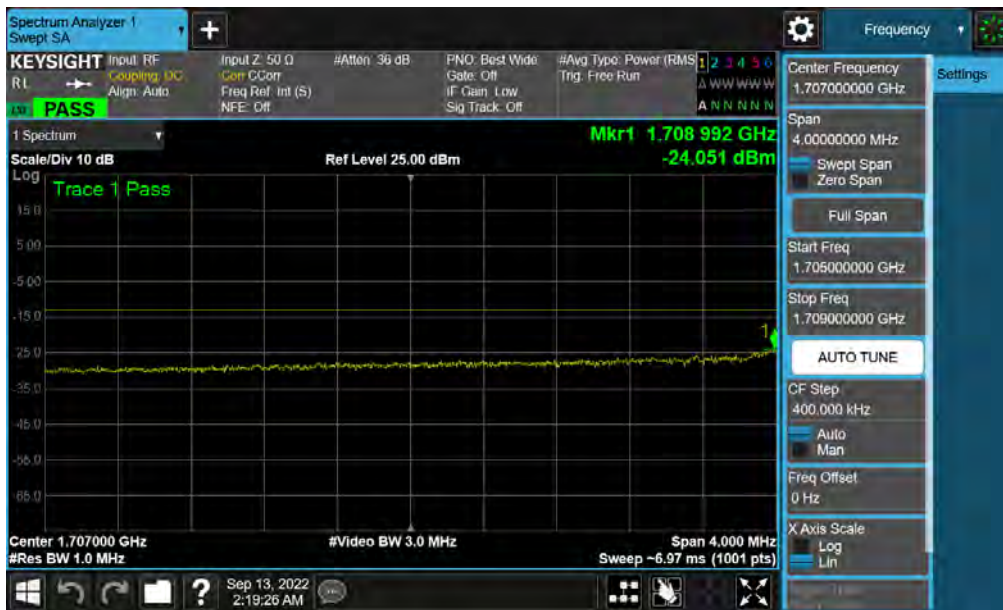
FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1M2212080137-03-R1.A3L	Test Dates: 12/13/2022 - 12/20/2022	EUT Type: Portable Handset	Page 52 of 90



FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1M2212080137-03-R1.A3L	Test Dates: 12/13/2022 - 12/20/2022	EUT Type: Portable Handset	Page 53 of 90



FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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Plot 7-76. Upper Band Edge Plot (LTE Band 4 - 10MHz QPSK – Full RB)

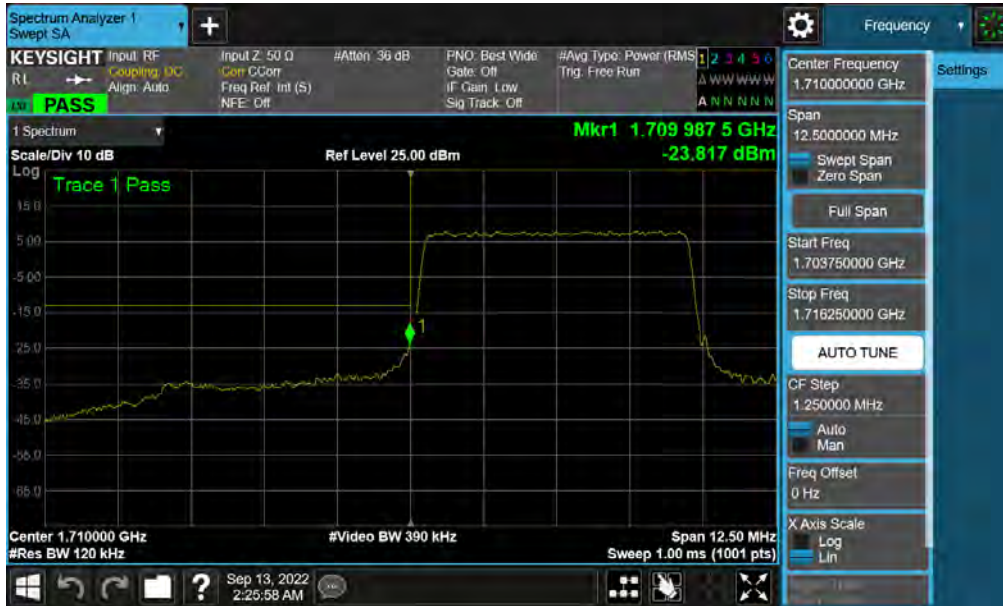


Plot 7-77. Upper Extended Band Edge Plot (LTE Band 4 - 10MHz QPSK – Full RB)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1M2212080137-03-R1.A3L	Test Dates: 12/13/2022 - 12/20/2022	EUT Type: Portable Handset	Page 56 of 90



FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1M2212080137-03-R1.A3L	Test Dates: 12/13/2022 - 12/20/2022	EUT Type: Portable Handset	Page 57 of 90



FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1M2212080137-03-R1.A3L	Test Dates: 12/13/2022 - 12/20/2022	EUT Type: Portable Handset	Page 58 of 90

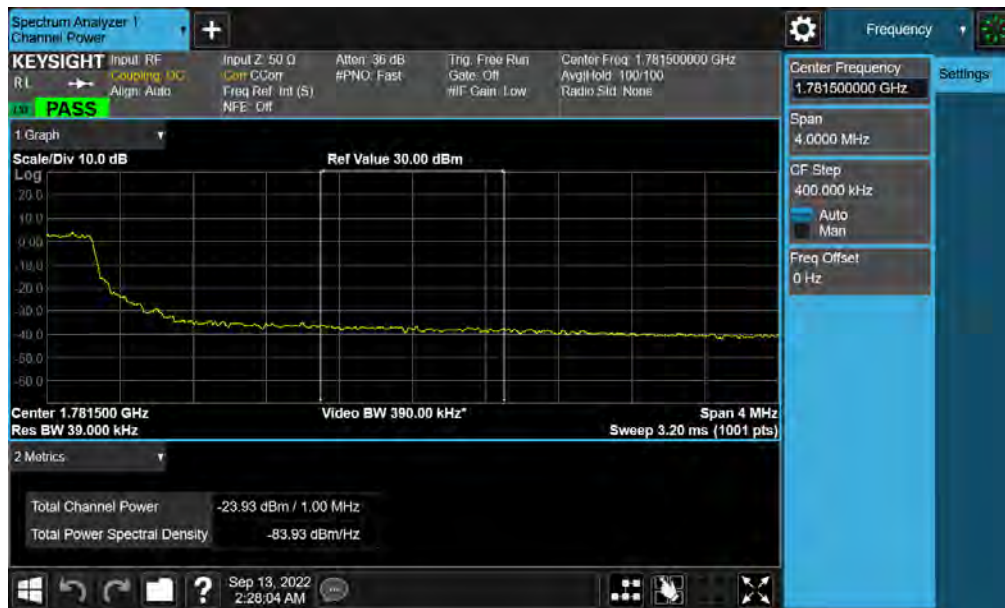


Plot 7-82. Upper Band Edge Plot (LTE Band 4 - 5MHz QPSK – Full RB)

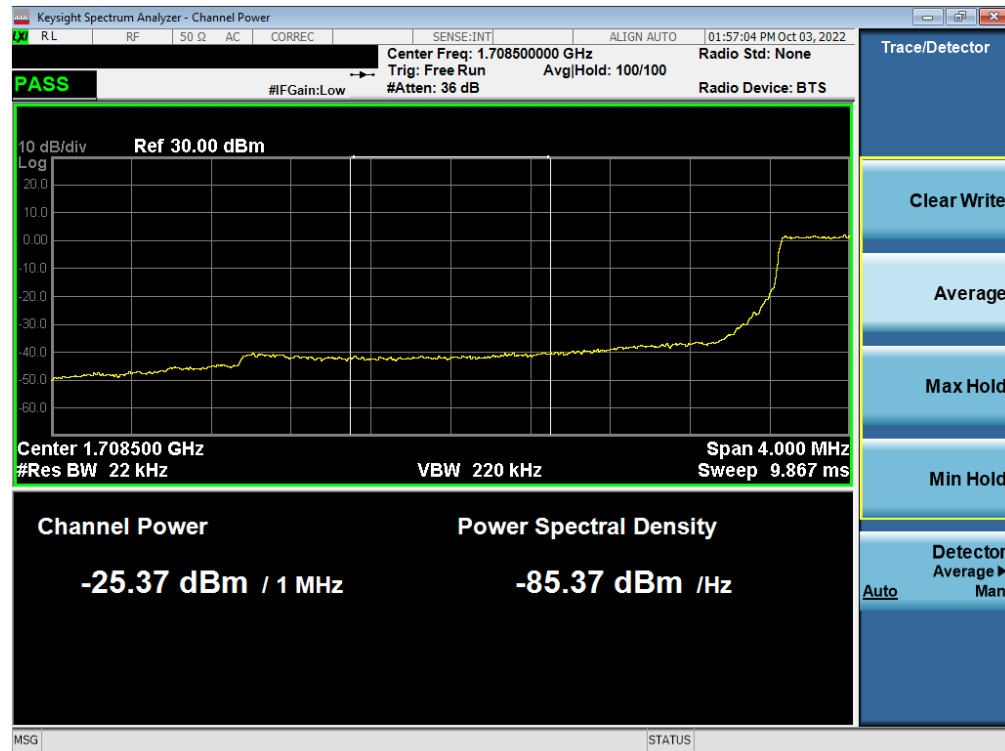


Plot 7-83. Upper Extended Band Edge Plot (LTE Band 4 - 5MHz QPSK – Full RB)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1M2212080137-03-R1.A3L	Test Dates: 12/13/2022 - 12/20/2022	EUT Type: Portable Handset	Page 59 of 90



FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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Plot 7-90. Upper Band Edge Plot (LTE Band 66 - 3MHz QPSK – Full RB)

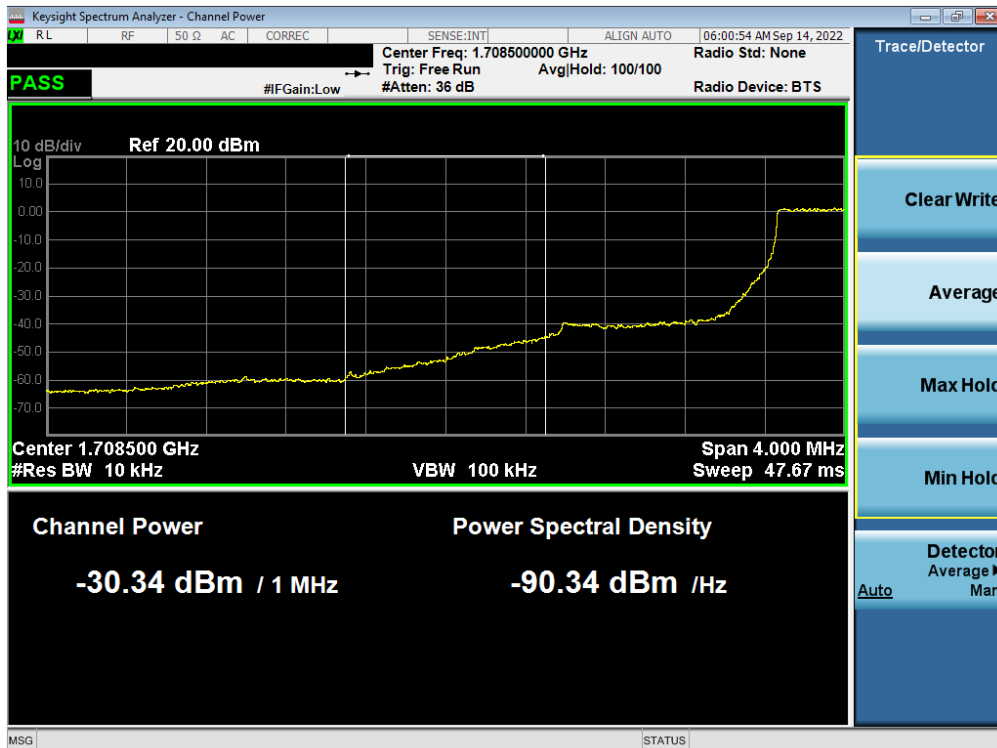


Plot 7-91. Upper Extended Band Edge Plot (LTE Band 66 - 3MHz QPSK – Full RB)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1M2212080137-03-R1.A3L	Test Dates: 12/13/2022 - 12/20/2022	EUT Type: Portable Handset	Page 63 of 90



Plot 7-92. Lower Band Edge Plot (LTE Band 66/4 - 1.4MHz QPSK - Full RB)

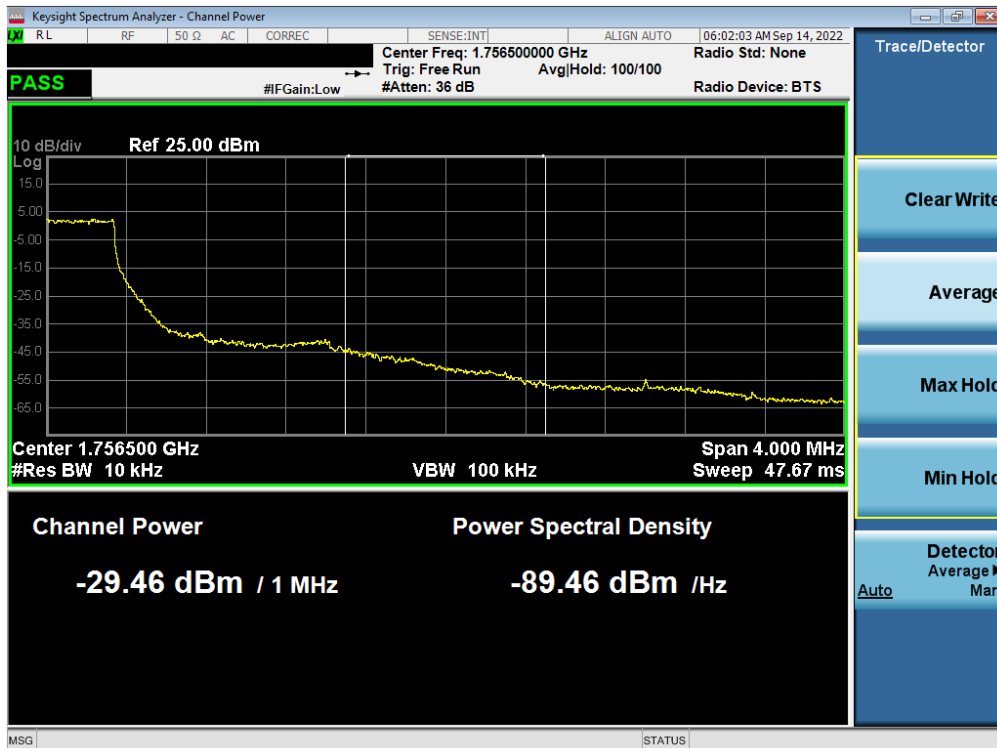


Plot 7-93. Lower Extended Band Edge Plot (LTE Band 66/4 - 1.4MHz QPSK - Full RB)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1M2212080137-03-R1.A3L	Test Dates: 12/13/2022 - 12/20/2022	EUT Type: Portable Handset	Page 64 of 90



Plot 7-94. Upper Band Edge Plot (LTE Band 4 – 1.4MHz QPSK – Full RB)

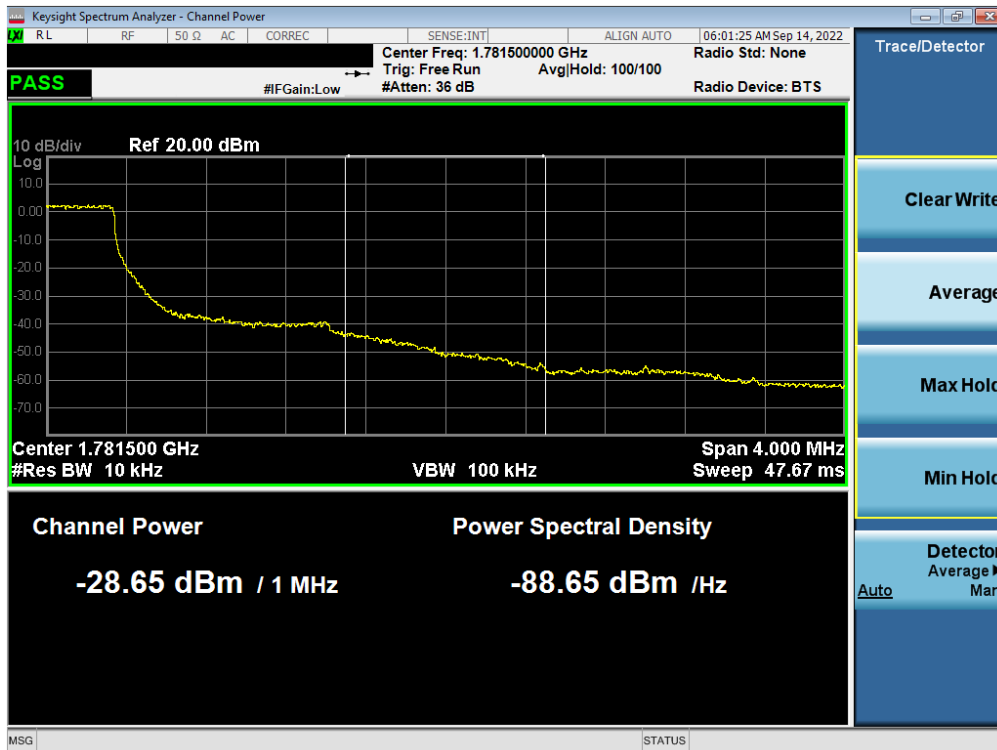


Plot 7-95. Upper Extended Band Edge Plot (LTE Band 4 – 1.4MHz QPSK – Full RB)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1M2212080137-03-R1.A3L	Test Dates: 12/13/2022 - 12/20/2022	EUT Type: Portable Handset	Page 65 of 90



Plot 7-96. Upper Band Edge Plot (LTE Band 66 – 1.4MHz QPSK – Full RB)



Plot 7-97. Upper Extended Band Edge Plot (LTE Band 66 – 1.4MHz QPSK – Full RB)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1M2212080137-03-R1.A3L	Test Dates: 12/13/2022 - 12/20/2022	EUT Type: Portable Handset	Page 66 of 90

7.6 Peak-Average Ratio

Test Overview

A peak to average ratio measurement is performed at the conducted port of the EUT. The spectrum analyzers Complementary Cumulative Distribution Function (CCDF) measurement profile is used to determine the largest deviation between the average and the peak power of the EUT in a given bandwidth. The CCDF curve shows how much time the peak waveform spends at or above a given average power level. The percent of time the signal spends at or above the level defines the probability for that particular power level.

Test Procedure Used

ANSI C63.26-2015 – Section 5.2.3.4

Test Settings

1. The signal analyzer's CCDF measurement profile is enabled
2. Frequency = carrier center frequency
3. Measurement BW \geq OBW or specified reference bandwidth
4. The signal analyzer was set to collect one million samples to generate the CCDF curve
5. The measurement interval was set depending on the type of signal analyzed. For continuous signals (>98% duty cycle), the measurement interval was set to 1ms. For burst transmissions, the spectrum analyzer is set to use an internal "RF Burst" trigger that is synced with an incoming pulse and the measurement interval is set to less than the duration of the "on time" of one burst to ensure that energy is only captured during a time in which the transmitter is operating at maximum power

Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.

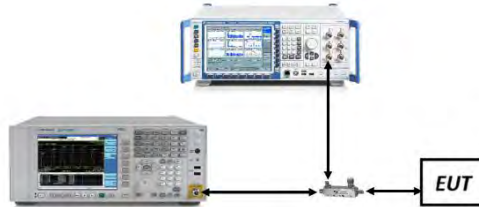


Figure 7-5. Test Instrument & Measurement Setup

Test Notes

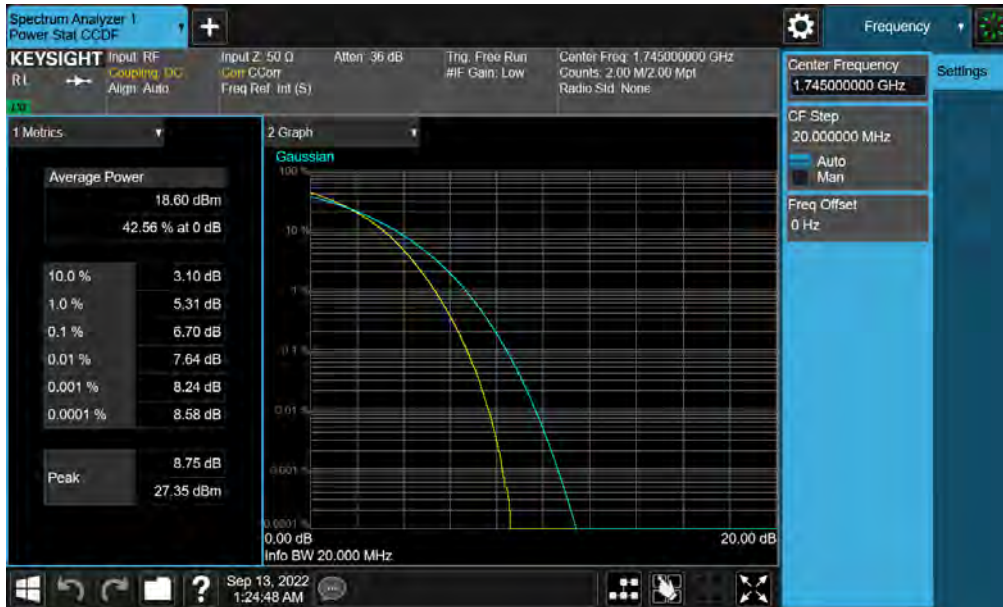
None.

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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LTE Band 66/4



Plot 7-98. PAR Plot (LTE Band 66/4 - 20MHz QPSK - Full RB)

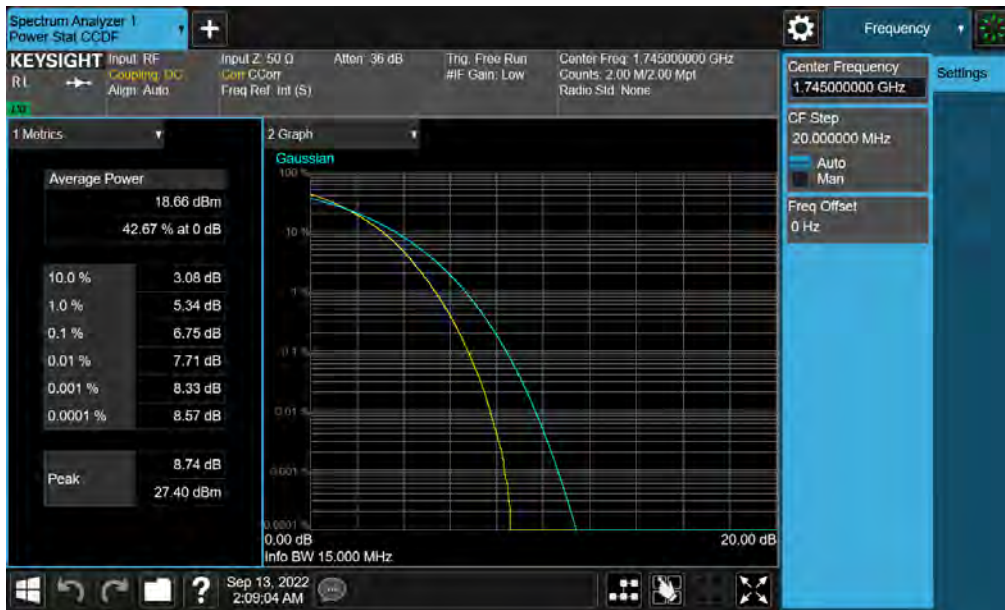


Plot 7-99. PAR Plot (LTE Band 66/4 - 20MHz 256-QAM - Full RB)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1M2212080137-03-R1.A3L	Test Dates: 12/13/2022 - 12/20/2022	EUT Type: Portable Handset	Page 68 of 90



Plot 7-100. PAR Plot (LTE Band 66/4 - 15MHz QPSK - Full RB)

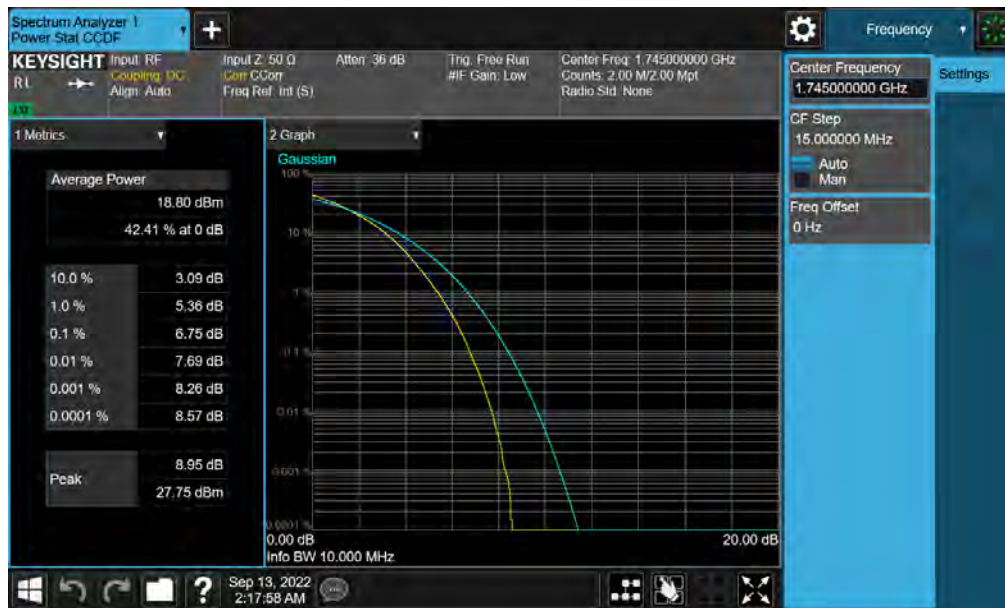


Plot 7-101. PAR Plot (LTE Band 66/4 - 15MHz 256-QAM - Full RB)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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Plot 7-102. PAR Plot (LTE Band 66/4 - 10MHz QPSK - Full RB)



Plot 7-103. PAR Plot (LTE Band 66/4 - 10MHz 256-QAM - Full RB)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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Plot 7-104. PAR Plot (LTE Band 66/4 - 5MHz QPSK - Full RB)



Plot 7-105. PAR Plot (LTE Band 66/4 - 5MHz 256-QAM - Full RB)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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Plot 7-106. PAR Plot (LTE Band 66/4 - 3MHz QPSK - Full RB)



Plot 7-107. PAR Plot (LTE Band 66/4 - 3MHz 256-QAM - Full RB)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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Plot 7-108. PAR Plot (LTE Band 66/4 - 1.4MHz QPSK - Full RB)



Plot 7-109. PAR Plot (LTE Band 66/4 - 1.4MHz 256-QAM - Full RB)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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7.7 Radiated Power (ERP/EIRP)

Test Overview

Effective Radiated Power (ERP) and Equivalent Isotropic Radiated Power (EIRP) measurements are performed using the substitution method described in ANSI C63.26-2015 with the EUT transmitting into an integral antenna. Measurements are performed using vertically and horizontally polarized broadband horn antennas. All measurements are performed as RMS average measurements while the EUT is operating at maximum power, and at the appropriate frequencies.

Test Procedures Used

ANSI C63.26-2015 – Section 5.2.4.4

Test Settings

1. Radiated power measurements are performed using the signal analyzer’s “channel power” measurement capability for signals with continuous operation.
2. RBW = 1 – 5% of the expected OBW, not to exceed 1MHz
3. VBW $\geq 3 \times$ RBW
4. Span = 1.5 times the OBW
5. No. of sweep points $\geq 2 \times$ span / RBW
6. Detector = RMS
7. Trigger is set to “free run” for signals with continuous operation with the sweep times set to “auto”.
8. The integration bandwidth was roughly set equal to the measured OBW of the signal for signals with continuous operation.
9. Trace mode = trace averaging (RMS) over 100 sweeps
10. The trace was allowed to stabilize

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Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.

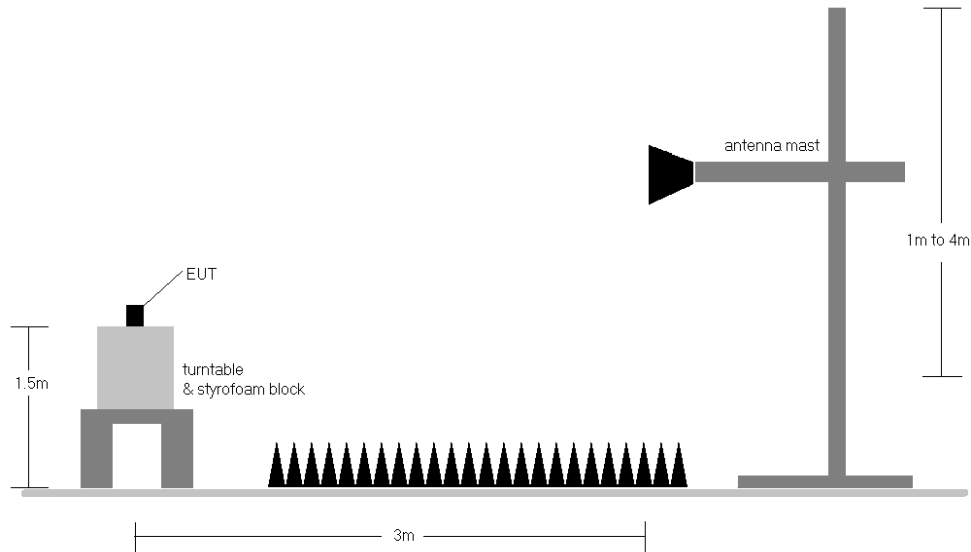


Figure 7-6. Radiated Test Setup <1GHz

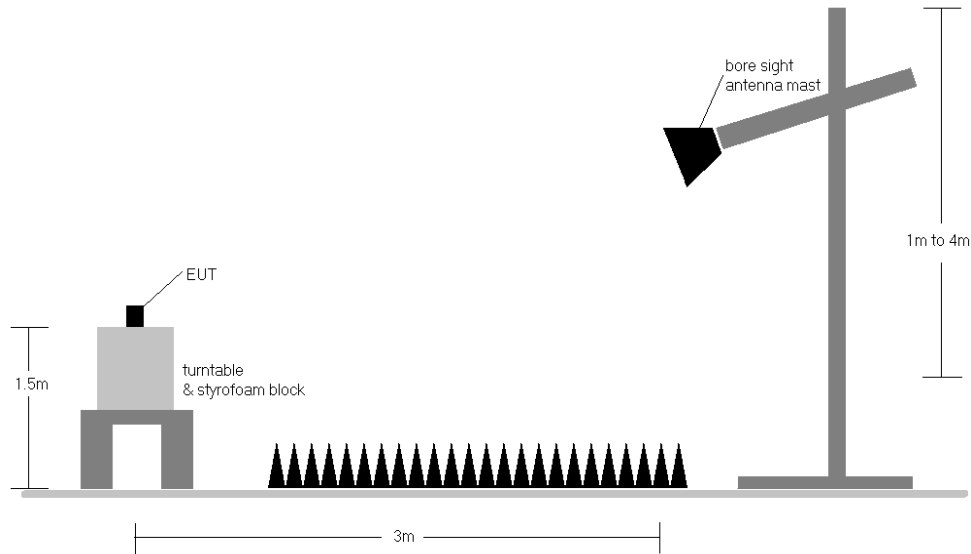


Figure 7-7. Radiated Test Setup >1GHz

Test Notes

- 1) The EUT was tested in three orthogonal planes and in all possible test configurations and positioning. The worst case emissions are reported with the EUT positioning, modulations, RB sizes and offsets, and channel bandwidth configurations shown in the tables below.
- 2) This unit was tested with its standard battery.

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7.8 Radiated Spurious Emissions Measurements

Test Overview

Radiated spurious emissions measurements are performed using the field strength conversion method described in ANSI C63.26-2015 with the EUT transmitting into an integral antenna. Measurements on signals operating below 1GHz are performed using hybrid (biconical/log) antennas. Measurements on signals operating above 1GHz are performed using vertically and horizontally polarized broadband horn antennas. All measurements are performed as RMS measurements while the EUT is operating at maximum power, and at the appropriate frequencies.

Test Procedures Used

ANSI C63.26-2015 – Section 5.5.4

Test Settings

1. RBW = 100kHz for emissions below 1GHz and 1MHz for emissions above 1GHz
2. VBW $\geq 3 \times$ RBW
3. Span = 1.5 times the OBW
4. No. of sweep points $\geq 2 \times$ span / RBW
5. Detector = RMS
6. Trace mode = Average (Max Hold for pulsed emissions)
7. The trace was allowed to stabilize

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.

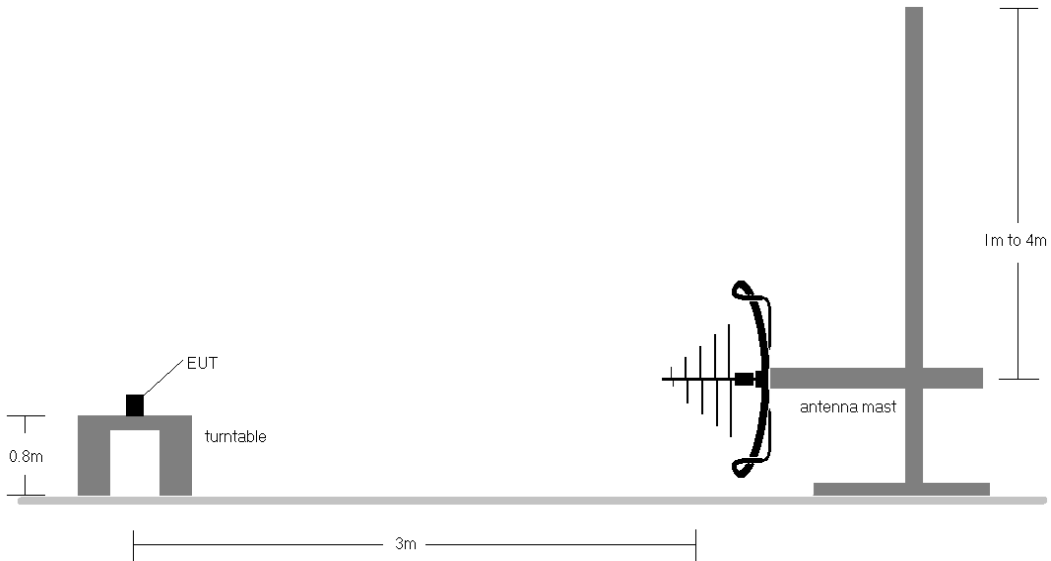


Figure 7-8. Test Instrument & Measurement Setup < 1GHz

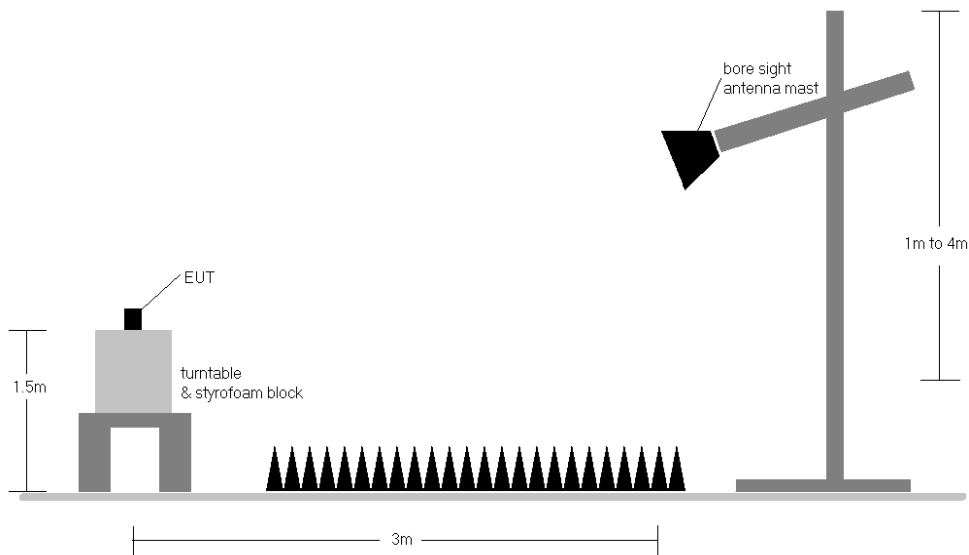


Figure 7-9. Test Instrument & Measurement Setup > 1GHz

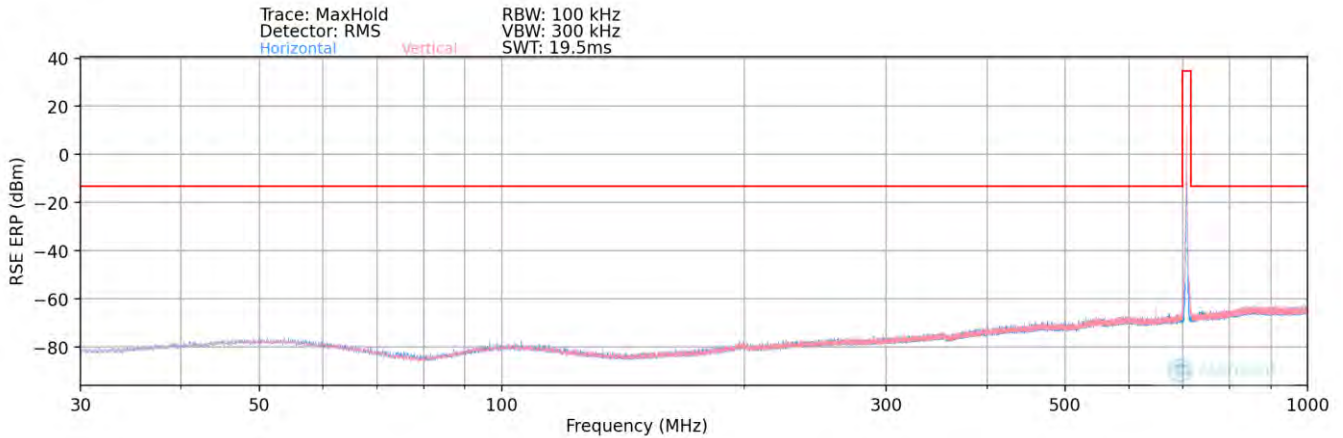
FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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Test Notes

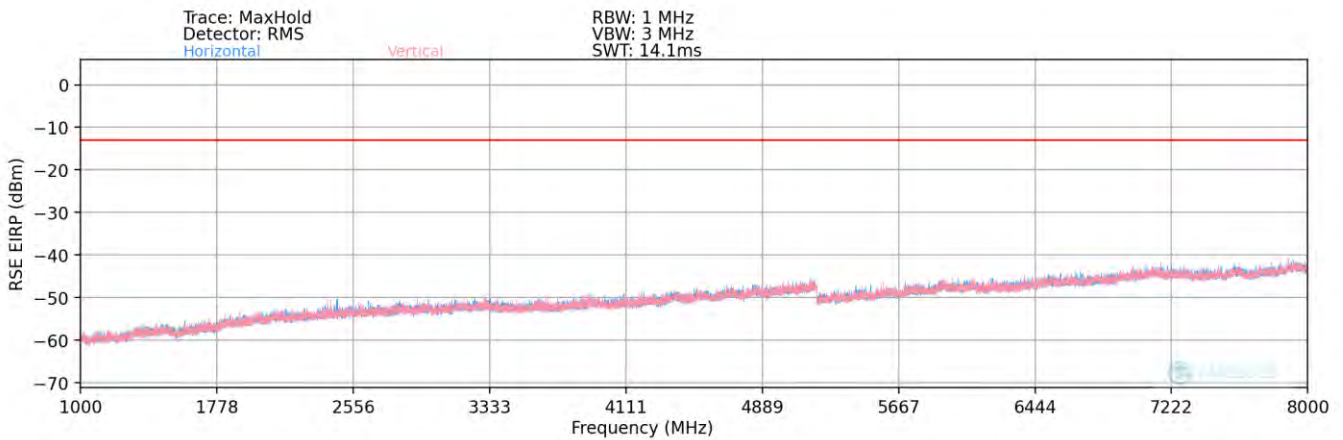
- 1) Field strengths are calculated using the Measurement quantity conversions in ANSI C63.26-2015 Section 5.2.7:
 - a) $E(\text{dB}\mu\text{V}/\text{m}) = \text{Measured amplitude level (dBm)} + 107 + \text{Cable Loss (dB)} + \text{Antenna Factor (dB/m)}$
 - b) $\text{EIRP (dBm)} = E(\text{dB}\mu\text{V}/\text{m}) + 20\log D - 104.8$; where D is the measurement distance in meters.
- 2) The EUT was tested in three orthogonal planes and in all possible test configurations and positioning. The worst case emissions are reported with the EUT positioning, modulations, RB sizes and offsets, and channel bandwidth configurations shown in the tables below.
- 3) This unit was tested with its standard battery.
- 4) The spectrum is measured from 9kHz to the 10th harmonic of the fundamental frequency of the transmitter. The worst-case emissions are reported.
- 5) Emissions below 18GHz were measured at a 3 meter test distance while emissions above 18GHz were measured at a 1 meter test distance with the application of a distance correction factor.
- 6) The "-" shown in the following RSE tables are used to denote a noise floor measurement.

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LTE Band 12



Plot 7-110. Radiated Spurious Plot (LTE Band 12)



Plot 7-111. Radiated Spurious Plot (LTE Band 12)

Mode:	Stand Alone
Channel:	23095
Frequency (MHz):	707.5
Detector / Trace Mode:	RMS / Average
RBW / VBW:	100kHz / 300kHz

Frequency [MHz]	Ant. Pol. [H/V]	Antenna Height [cm]	Turntable Azimuth [degree]	Analyzer Level [dBm]	AFCL [dB/m]	Field Strength [dBμV/m]	ERP Spurious Emission Level [dBm]	Limit [dBm]	Margin [dB]
647.39	V	161	94	-72.83	-5.96	28.21	-69.20	-13.00	-56.20

Table 7-6. Radiated Spurious Data (LTE Band 12)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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Bandwidth (MHz):	10
Frequency (MHz):	704
RB / Offset:	1 / 25

Frequency [MHz]	Ant. Pol. [H/V]	Antenna Height [cm]	Turntable Azimuth [degree]	Analyzer Level [dBm]	AFCL [dB/m]	Field Strength [dBμV/m]	EIRP Spurious Emission Level [dBm]	Limit [dBm]	Margin [dB]
1408.00	V	-	-	-77.20	-0.50	29.30	-65.96	-13.00	-52.96
2112.00	V	-	-	-77.21	4.03	33.82	-61.44	-13.00	-48.44
2816.00	V	-	-	-79.20	5.72	33.52	-61.74	-13.00	-48.74

Table 7-7. Radiated Spurious Data (LTE Band 12 – Low Channel)

Bandwidth (MHz):	10
Frequency (MHz):	707.5
RB / Offset:	1 / 25

Frequency [MHz]	Ant. Pol. [H/V]	Antenna Height [cm]	Turntable Azimuth [degree]	Analyzer Level [dBm]	AFCL [dB/m]	Field Strength [dBμV/m]	EIRP Spurious Emission Level [dBm]	Limit [dBm]	Margin [dB]
1415.00	V	-	-	-77.25	-0.54	-77.25	-77.79	-13.00	-64.79
2122.50	V	-	-	-77.56	4.01	-77.56	-73.55	-13.00	-60.55
2830.00	V	-	-	-79.32	5.88	-79.32	-73.44	-13.00	-60.44

Table 7-8. Radiated Spurious Data (LTE Band 12 – Mid Channel)

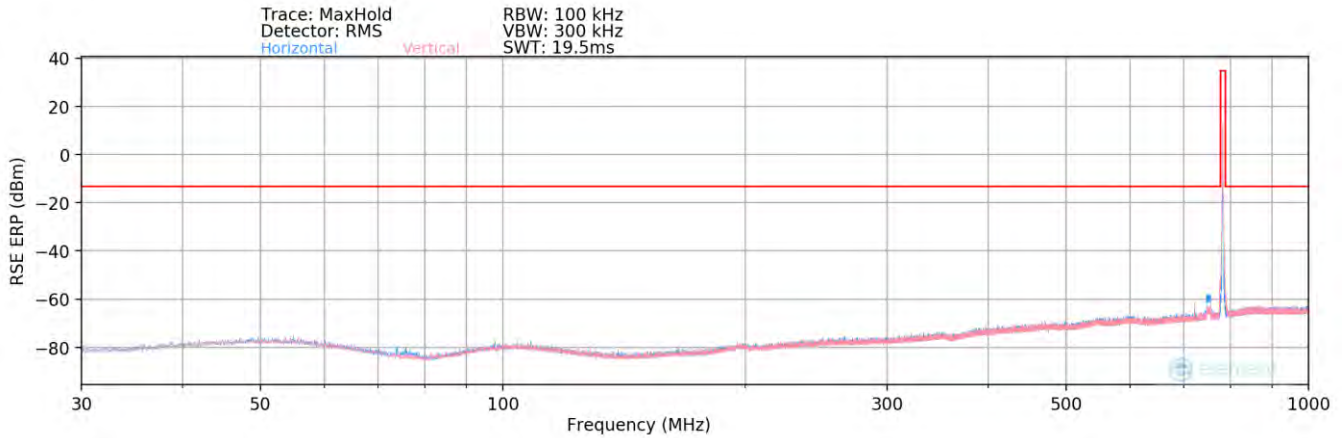
Bandwidth (MHz):	10
Frequency (MHz):	711
RB / Offset:	1 / 25

Frequency [MHz]	Ant. Pol. [H/V]	Antenna Height [cm]	Turntable Azimuth [degree]	Analyzer Level [dBm]	AFCL [dB/m]	Field Strength [dBμV/m]	EIRP Spurious Emission Level [dBm]	Limit [dBm]	Margin [dB]
1422.00	V	-	-	-77.35	-0.46	29.19	-66.07	-13.00	-53.07
2133.00	V	-	-	-77.32	3.93	33.61	-61.65	-13.00	-48.65
2844.00	V	-	-	-79.22	5.66	33.44	-61.82	-13.00	-48.82

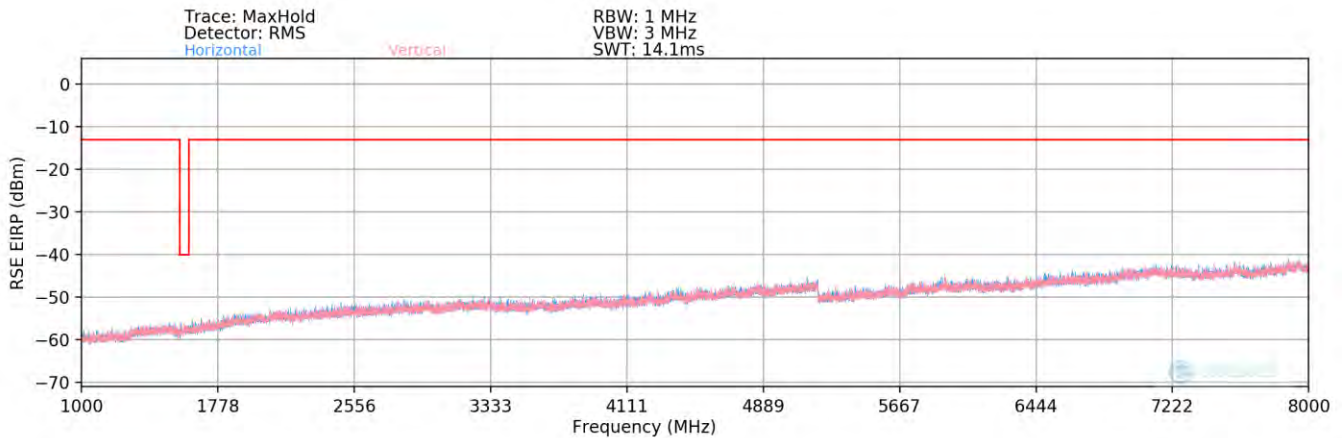
Table 7-9. Radiated Spurious Data (LTE Band 12 – High Channel)

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LTE Band 13



Plot 7-112. Radiated Spurious Plot (LTE Band 13)



Plot 7-113. Radiated Spurious Plot (LTE Band 13)

Mode:	Stand Alone
Channel:	23230
Frequency (MHz):	782
Detector / Trace Mode:	RMS / Average
RBW / VBW:	100kHz / 300kHz

Frequency [MHz]	Ant. Pol. [H/V]	Antenna Height [cm]	Turntable Azimuth [degree]	Analyzer Level [dBm]	AFCL [dB/m]	Field Strength [dBμV/m]	ERP Spurious Emission Level [dBm]	Limit [dBm]	Margin [dB]
75.50	V	-	-	-70.50	-21.13	15.37	-82.04	-13.00	-69.04
207.12	V	-	-	-69.77	-17.03	20.20	-77.21	-13.00	-64.21
338.57	V	-	-	-69.25	-13.01	24.74	-72.67	-13.00	-59.67
545.85	V	-	-	-67.67	-9.13	30.20	-67.21	-13.00	-54.21
772.09	V	250	70	-65.29	-5.58	36.13	-61.28	-13.00	-48.28

Table 7-10. Radiated Spurious Data (LTE Band 13)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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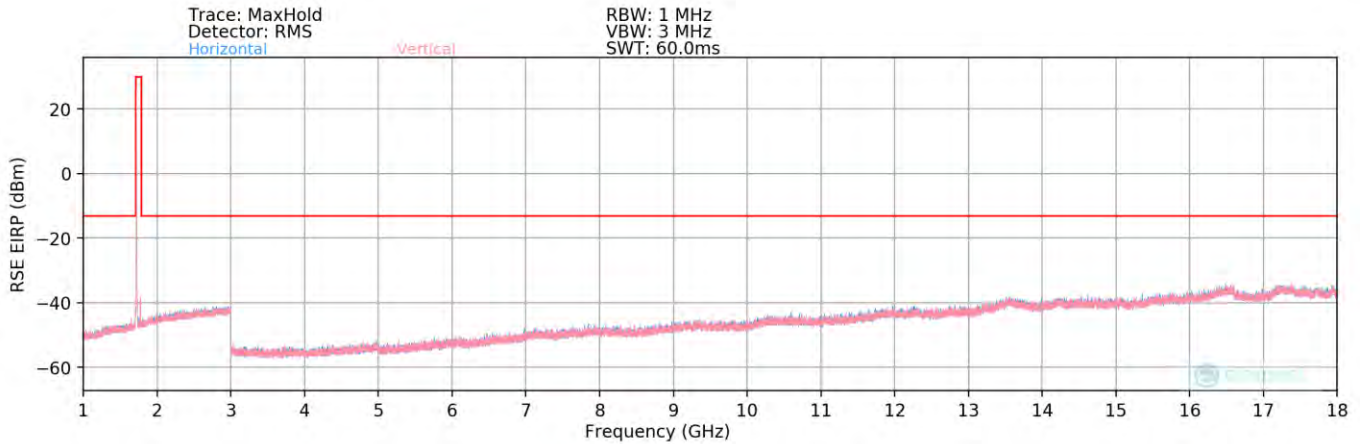
Bandwidth (MHz):	10
Frequency (MHz):	782
RB / Offset:	1 / 25

Frequency [MHz]	Ant. Pol. [H/V]	Antenna Height [cm]	Turntable Azimuth [degree]	Analyzer Level [dBm]	AFCL [dB/m]	Field Strength [dBμV/m]	EIRP Spurious Emission Level [dBm]	Limit [dBm]	Margin [dB]
1564.00	V	249	100	-77.81	-0.28	28.91	-66.34	-40.00	-26.34
2346.00	V	-	-	-78.92	4.26	32.34	-62.92	-13.00	-49.92
3128.00	V	-	-	-79.74	6.42	33.68	-61.57	-13.00	-48.57
3910.00	V	-	-	-80.42	8.19	34.77	-60.49	-13.00	-47.49
4692.00	V	-	-	-81.02	9.56	35.54	-59.72	-13.00	-46.72

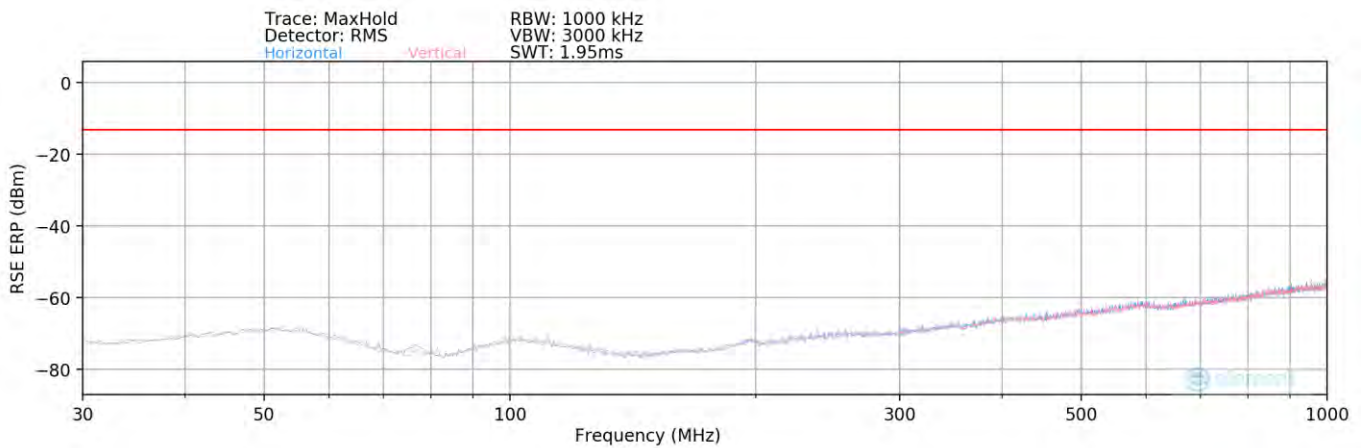
Table 7-11. Radiated Spurious Data (LTE Band 13 – Low Channel)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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LTE Band 66/4



Plot 7-114. Radiated Spurious Plot (LTE Band 66/4)



Plot 7-115. Radiated Spurious Plot (LTE Band 66/4)

Mode:	Stand Alone
Channel:	132072
Frequency (MHz):	1720
Detector / Trace Mode:	RMS / Average
RBW / VBW:	100kHz / 300kHz

Frequency [MHz]	Ant. Pol. [H/V]	Antenna Height [cm]	Turntable Azimuth [degree]	Analyzer Level [dBm]	AFCL [dB/m]	Field Strength [dBμV/m]	ERP Spurious Emission Level [dBm]	Limit [dBm]	Margin [dB]
76.73	H	250	114	-61.16	-21.52	24.32	-73.09	-13.00	-60.09
536.25	V	-	-	-61.71	-9.28	36.01	-61.40	-13.00	-48.40
554.98	H	-	-	-62.42	-9.12	35.46	-61.95	-13.00	-48.95
934.78	H	-	-	-62.58	-3.68	40.74	-56.67	-13.00	-43.67
955.30	V	-	-	-60.97	-3.49	42.54	-54.87	-13.00	-41.87

Table 7-12. Radiated Spurious Data (LTE Band 66/4)

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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Bandwidth (MHz):	20
Frequency (MHz):	1720
RB / Offset:	1 / 50

Frequency [MHz]	Ant. Pol. [H/V]	Antenna Height [cm]	Turntable Azimuth [degree]	Analyzer Level [dBm]	AFCL [dB/m]	Field Strength [dBµV/m]	EIRP Spurious Emission Level [dBm]	Limit [dBm]	Margin [dB]
3440.00	V	-	-	-70.70	7.28	43.58	-51.68	-13.00	-38.68
5160.00	V	-	-	-73.55	10.22	43.67	-51.58	-13.00	-38.58
6880.00	V	-	-	-73.06	13.79	47.73	-47.53	-13.00	-34.53
8600.00	V	-	-	-75.15	16.98	48.83	-46.43	-13.00	-33.43
10320.00	V	-	-	-74.82	19.79	51.97	-43.29	-13.00	-30.29

Table 7-13. Radiated Spurious Data (LTE Band 66/4 – Low Channel)

Bandwidth (MHz):	20
Frequency (MHz):	1745
RB / Offset:	1 / 50

Frequency [MHz]	Ant. Pol. [H/V]	Antenna Height [cm]	Turntable Azimuth [degree]	Analyzer Level [dBm]	AFCL [dB/m]	Field Strength [dBµV/m]	EIRP Spurious Emission Level [dBm]	Limit [dBm]	Margin [dB]
3490.00	V	-	-	-71.35	7.19	42.84	-52.42	-13.00	-39.42
5235.00	V	-	-	-73.24	9.90	43.66	-51.60	-13.00	-38.60
6980.00	V	-	-	-73.49	14.03	47.54	-47.72	-13.00	-34.72
8725.00	V	-	-	-74.26	16.98	49.72	-45.54	-13.00	-32.54
10470.00	V	-	-	-75.63	19.71	51.08	-44.18	-13.00	-31.18

Table 7-14. Radiated Spurious Data (LTE Band 66/4 – Mid Channel)

Bandwidth (MHz):	20
Frequency (MHz):	1770
RB / Offset:	1 / 50

Frequency [MHz]	Ant. Pol. [H/V]	Antenna Height [cm]	Turntable Azimuth [degree]	Analyzer Level [dBm]	AFCL [dB/m]	Field Strength [dBµV/m]	EIRP Spurious Emission Level [dBm]	Limit [dBm]	Margin [dB]
3540.00	V	-	-	-71.96	7.50	42.54	-52.72	-13.00	-39.72
5310.00	V	-	-	-72.78	10.45	44.67	-50.59	-13.00	-37.59
7080.00	V	-	-	-73.47	14.28	47.81	-47.45	-13.00	-34.45
8850.00	V	-	-	-73.91	17.47	50.56	-44.69	-13.00	-31.69
10620.00	V	-	-	-75.28	20.07	51.79	-43.47	-13.00	-30.47

Table 7-15. Radiated Spurious Data (LTE Band 66/4 – High Channel)

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7.9 Frequency Stability / Temperature Variation

Test Overview and Limit

Frequency stability testing is performed in accordance with the guidelines of ANSI C63.26-2015. The frequency stability of the transmitter is measured by:

- a.) **Temperature:** The temperature is varied from -30°C to +50°C in 10°C increments using an environmental chamber.
- b.) **Primary Supply Voltage:** The primary supply voltage is varied from 85% to 115% of the nominal value for non hand-carried battery and AC powered equipment. For hand-carried, battery-powered equipment, primary supply voltage is reduced to the battery operating end point which shall be specified by the manufacturer.

For Part 27, the frequency stability shall be sufficient to ensure that the fundamental emission stays within the authorized frequency block.

Test Procedure Used

ANSI C63.26-2015 – Section 5.6

Test Settings

1. The carrier frequency of the transmitter is measured at room temperature (20°C to provide a reference).
2. The equipment is turned on in a “standby” condition for fifteen minutes before applying power to the transmitter. Measurement of the carrier frequency of the transmitter is made within one minute after applying power to the transmitter.
3. Frequency measurements are made at 10°C intervals ranging from -30°C to +50°C. A period of at least one half-hour is provided to allow stabilization of the equipment at each temperature level.

Test Setup

The EUT was connected via an RF cable to a spectrum analyzer with the EUT placed inside an environmental chamber.

Test Notes

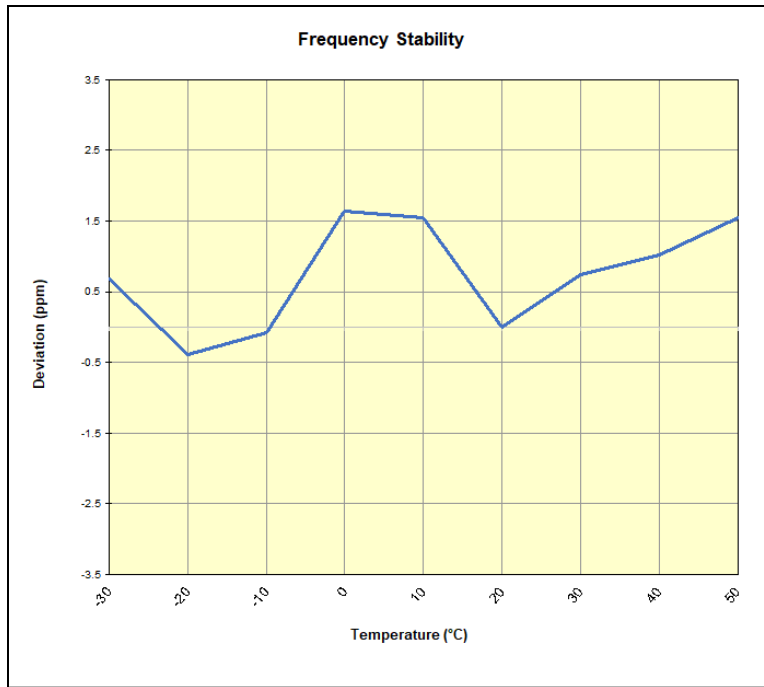
None

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Frequency Stability / Temperature Variation

LTE Band 12					
Operating Frequency (Hz):		707,500,000			
Ref. Voltage (VDC):		4.28			
Deviation Limit:		± 0.00025% or 2.5 ppm			
Voltage (%)	Power (VDC)	Temp (°C)	Frequency (Hz)	Freq. Dev. (Hz)	Deviation (%)
100 %	4.28	- 30	707,595,641	480	0.0000678
		- 20	707,594,883	-278	-0.0000393
		- 10	707,595,111	-50	-0.0000071
		0	707,596,322	1,161	0.0001641
		+ 10	707,596,255	1,094	0.0001546
		+ 20 (Ref)	707,595,161	0	0.0000000
		+ 30	707,595,689	528	0.0000746
		+ 40	707,595,879	718	0.0001015
Battery Endpoint	3.47	+ 20	707,596,241	1,080	0.0001526

Table 7-16. LTE Band 12 Frequency Stability Data



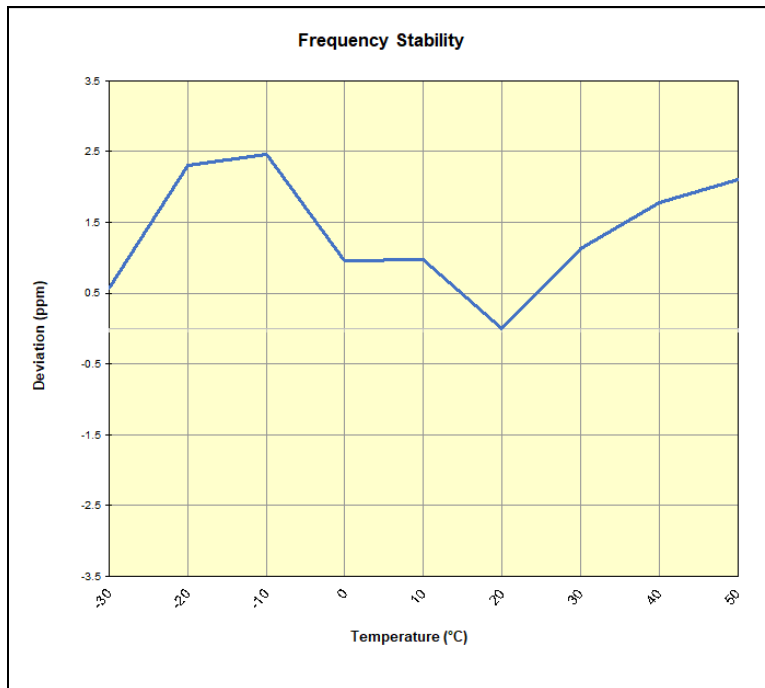
Plot 7-116. LTE Band 12 Frequency Stability Chart

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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Frequency Stability / Temperature Variation

LTE Band 13					
Operating Frequency (Hz):		782,000,000			
Ref. Voltage (VDC):		4.28			
Deviation Limit:		± 0.00025% or 2.5 ppm			
Voltage (%)	Power (VDC)	Temp (°C)	Frequency (Hz)	Freq. Dev. (Hz)	Deviation (%)
100 %	4.28	- 30	782,095,926	443	0.0000566
		- 20	782,097,292	1,809	0.0002313
		- 10	782,097,403	1,920	0.0002455
		0	782,096,239	756	0.0000967
		+ 10	782,096,243	760	0.0000972
		+ 20 (Ref)	782,095,483	0	0.0000000
		+ 30	782,096,364	881	0.0001126
		+ 40	782,096,879	1,396	0.0001785
Battery Endpoint	3.47	+ 20	782,093,580	-1,903	-0.0002433

Table 7-17. LTE Band 13 Frequency Stability Data



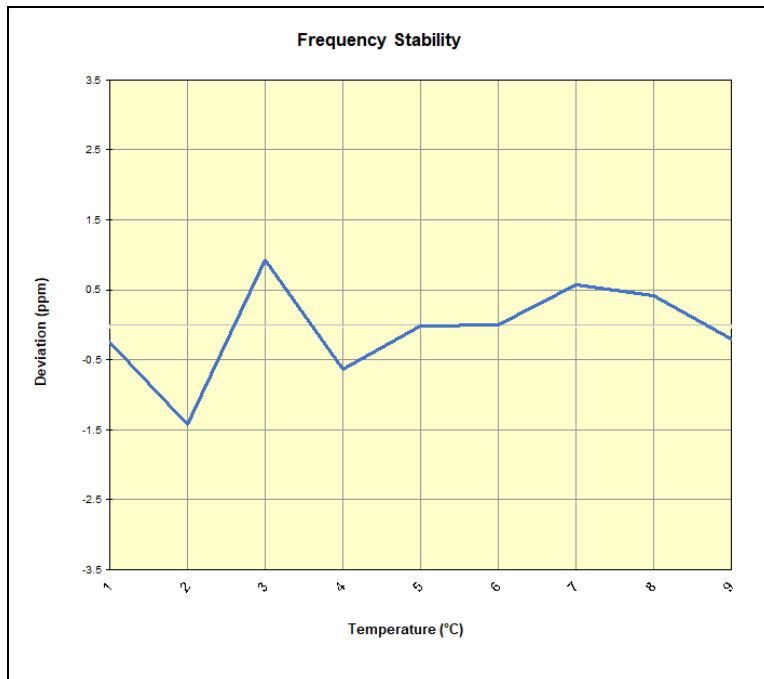
Plot 7-117. LTE Band 13 Frequency Stability Chart

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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Frequency Stability / Temperature Variation

LTE Band 66/4					
		Operating Frequency (Hz):		1,745,000,000	
		Ref. Voltage (VDC):		4.28	
		Deviation Limit:		± 0.00025% or 2.5 ppm	
Voltage (%)	Power (VDC)	Temp (°C)	Frequency (Hz)	Freq. Dev. (Hz)	Deviation (%)
100 %	4.28	- 30	1,745,106,830	-431	-0.0000247
		- 20	1,745,104,774	-2,487	-0.0001425
		- 10	1,745,108,885	1,624	0.0000931
		0	1,745,106,147	-1,114	-0.0000638
		+ 10	1,745,107,244	-17	-0.0000010
		+ 20 (Ref)	1,745,107,261	0	0.0000000
		+ 30	1,745,108,247	986	0.0000565
		+ 40	1,745,107,987	726	0.0000416
Battery Endpoint	3.47	+ 20	1,745,107,987	726	0.0000416

Table 7-18. LTE Band 66/4 Frequency Stability Data



Plot 7-118. LTE Band 66/4 Frequency Stability Chart

FCC ID: A3LSMS918JPN	PART 27 MEASUREMENT REPORT		Approved by: Technical Manager
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8.0 CONCLUSION

The data collected relate only to the item(s) tested and show that the **Samsung Portable Handset FCC ID: A3LSMS918JPN** complies with all the requirements of Part 27 of the FCC rules.

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